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Graphene-like emerging 2D materials: recent progress, challenges and future outlook

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Owing to the unique physical and chemical properties of 2D materials and the great success of graphene in various applications, the scientific community has been influenced to explore a new class of graphene-like 2D materials for next-generation technological applications. Consequently, many alternative layered and non-layered 2D materials, including h-BN, TMDs, and MXenes, have been synthesized recently for applications related to the 4th industrial revolution. In this review, recent progress in state-of-the-art research on 2D materials, including their synthesis routes, characterization and application-oriented properties, has been highlighted. The evolving applications of 2D materials in the areas of electronics, optoelectronics, spintronic devices, sensors, high-performance and transparent electrodes, energy conversion and storage, electromagnetic interference shielding, hydrogen evolution reaction (HER), oxygen evolution reaction (OER), and nanocomposites are discussed. In particular, the state-of-the-art applications, challenges, and outlook of every class of 2D material are also presented as concluding remarks to guide this fast-progressing class of 2D materials beyond graphene for scientific research into next-generation materials.

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1. Introduction

We are currently in the age of nanotechnology that is the basis of technological evolution and where the innovation of more sustainable and economical unique materials has noticeably increased. After the discovery of graphene with its physicochemical properties and applications, the door has opened to a world of 2D materials due to their extraordinary properties that have become an extensive area of research in recent years.^{1–3} Advances in graphene applications and fundamental studies have attracted scientists to develop a surfeit of 2D materials and to search for new members of the 2D family. Remarkably, the collection of 2D-layered materials are among the most widely studied materials due to their unique physical peculiarities and a considerable number of new materials are

now being provided and added to the list every year; currently the family has more than 150 members.

In 2004, scientists were first able to isolate a single-layer plane of graphene using the adhesive tape technique and graphene showed unique and exciting electronic properties.^{4,5} This success aroused huge interest in the large-scale production of 2D materials. Over the last decade, scientists have successfully exfoliated van der Waals materials (both chemically and mechanically) into single and few layers.⁶ This technique has elaborated the field of 2D materials beyond graphene and given birth to many ‘cousins’, as shown in Fig. 1, such as hexagonal boron nitride (h-BN), black phosphorus (BP), transition metal dichalcogenides (TMDs, MX₂), metal-organic frameworks (MOFs), layered double hydroxides (LDHs), covalent organic frameworks (COFs), a family of monoelemental compounds (Xenes), metal oxides, graphitic carbon nitride (g-C₃N₄), metal nitrides/carbides (MXenes), 12–15 transition metal halides (TMHs) (e.g., PbI₂ and MgBr₂), perovskite-type oxides (e.g., K₂Ln₂Ti₃O₁₀ and RbLnTa₂O₇ (Ln: lanthanide ion)), and 2D polymers.

Graphene, a previously isolated carbon material, is acting as a building block to search for other family members based on dimensionality. Single-layered TMDs have attracted devotion due to their natural abundance and assorted applications. TMDs with the chemical formula MX₂ (where M is a transition metal from groups 4–10, such as Mo, Nb, W, Ni, V, or Re, and X is a chalcogen such as Se, Te, or S).^{6–9} Currently, 40 various

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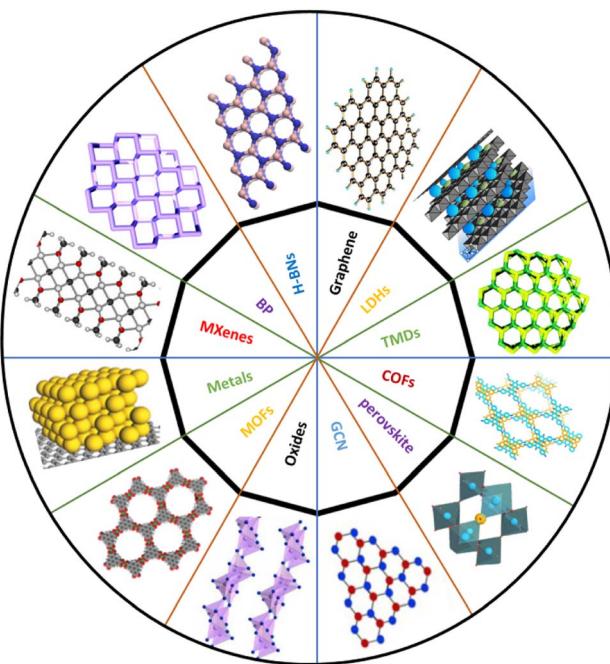


Fig. 1 Illustration of different kinds of typical 2D materials.

combinations of TMDs with different chalcogen atoms have been revealed, as illustrated in Fig. 2(a). TMDs exhibit a variety of structures according to the oxidation state of their atoms and coordination number such as metals (NbSe_2 shows a superconductivity effect at low temperature),^{10–12} semimetals (TiSe_2),¹³ semiconductors (MoS_2)¹⁴ and insulators (HfS_2).⁵

Intense research efforts have been put into the fast development of abundant synthesized compositions. Hexagonal boron nitride (h-BN), metal chalcogenides, metal oxides, metal halides, metal carbides/nitrides (MXenes), and organic semiconductors (OSCs) are considered prospective 2D materials based on their diverse applications in different devices. Almost all the atoms on the surface of these materials are exposed after exfoliation (ultrathin form); thus, the surface areas of 2D materials are noticeably increased, which significantly increases their physical and chemical reactivity and influences the 2D work function through quantum confinement effects. To date, about 30 MXene-based compositions have been reported (shown by the blue color in Fig. 2(b)), and several others have been surveyed through computational means (shown by the gray color in Fig. 2(b)).

2D materials exhibit novel and exciting properties, so that people are expecting many innovative openings. This review emphasizes the highest degree of development of graphene-like materials. First, we will introduce the overview, classification, and characterization of 2D materials followed by the properties of 2D materials. We also discuss in detail the synthesis routes of each class of 2D material along with the basic principles and importance of emerging techniques for their elite applications and experimental guidance for distinguishing and describing single or multilayer materials. We detail the challenges and future research directions for each

class of 2D materials in the respective sections for a better understanding of what needs to be fixed to accelerate their emerging applications. Finally, we elucidate various newly developed 2D materials, their properties and prospects of single and multilayers and many layers in field-effect transistors, energy conversion and storage, electrochemical performance and many other applications.

2. Synthesis methods for 2D materials

Nucleation and growth regulate the main mechanism of conventional crystal development¹⁶ and the arrangement of atomic order deemed to be the stable state, as shown in Fig. 3(a). Modern scientists have discovered that an amorphous precursor may be a crucial transitional outcome in the process of crystal formation, particularly in bio-mineralization.¹⁷ At the beginning, they may accumulate prior to nucleation for prevailing scattered atomic organization, as shown in Fig. 3(b). Therefore, hindering the conversion from amorphous to crystal phase is the main phenomenon in the synthesis of amorphous materials. It is found in the literature that coordination/adsorption¹⁸ and lattice distortion¹⁹ among others are the possible alternative routes for the fabrication of amorphous 2D nanomaterials.

Essentially, these techniques are classified into two major types: top-down and bottom-up processes. In the top-down method, the 2D membrane of the materials is achieved through by breaking down the respective bulk precursors by adopting different physical or chemical techniques: the Scotch-tape method, chemical exfoliation, *etc.* In practice, the top-down method can synthesise nearly all compounds as 2D structures. On the other hand, bottom-up methods involve atom-by atom, molecule-by-molecule or cluster-by-cluster manipulation for the synthesis of nanostructures. Typical bottom-up methods, include laser deposition, ion exchange, electro-deposition, phase transformation, solvothermal colloidal chemistry techniques and 2D-structured synthesis, all of which depend on chemical reactions in certain experimental environments. 2D materials produced using different synthesis methods or techniques are later discussed with special care in their own sections.

3. Characterization methods for 2D materials

Numerous characterization techniques and protocols have been presented in different papers published by the 2D material research community. This is because the fundamental characterization paths are essential for ensuring the reproducibility of the as-produced materials.²¹ However, out-of-plane physical structures of 2D nanomaterials have a great impact on their various optical characteristics that could be investigated by the different microscopy methods. Various methods for the characterization of 2D nanomaterials have been implemented, such as structural analysis by X-ray diffraction (XRD), surface morphology analysis with the aid of various electron



| Graphene Family | Graphene | hBN 'white graphene' | BCN | Fluorographene | Graphene oxide |
|-------------------------------------|---------------------------------------------------------------------------|---------------------------------------------------------------------------------------------------------------------------|----------------------------------------------------------------------------------------------------------------------------------------|--------------------------------------------------------------------------------------|-------------------------------|
| 2D chalcogenides | MoS ₂ , WS ₂ , MoSe ₂ , WSe ₂ | Semiconducting dichalcogenides: MoTe ₂ , WTe ₂ , ZrS ₂ , ZrSe ₂ and so on. | Metallic dichalcogenides: NbSe ₂ , NbS ₂ , TaS ₂ , TiS ₂ , NiSe ₂ and so on. | | |
| | | Layered Cu oxides | TiO ₂ , MnO ₂ , V ₂ O ₅ , TaO ₃ , RuO ₂ , and so on | Layered semiconductors: GaSe, GaTe, InSe, Bi ₂ Se ₃ and so on. | |
| 2D Metal nitrides/ carbides (MXene) | M ₂ X | M ₃ X ₂ | M ₄ X ₃ | | M ₅ X ₄ |

| Sc ₂ C | Ti ₂ C | Ti ₂ N | Zr ₂ C | Ti ₃ C ₂ | Ti ₃ N ₂ | Ti ₃ (CN) | Zr ₃ C ₂ | Ti ₄ N ₃ | V ₄ C ₃ | Nb ₄ C ₃ | Ta ₄ C ₃ |
|-----------------------|------------------------|--------------------------------------|---------------------|--------------------------------------------------|---------------------------------------------------|---------------------------------------------------|---------------------------------------------------|----------------------------------------------------------------|----------------------------------------------------------------|-----------------------------------------------------------------|-----------------------------------------------------------------|
| Zr ₂ N | Hf ₂ C | Hf ₂ N | V ₂ C | (Ti ₂ V) ₃ C ₂ | (Ti ₂ ,Nb) ₂ C ₂ | (Ti ₂ ,Ta) ₂ C ₂ | (Ti ₂ ,Mn) ₂ C ₂ | (Ti ₁ ,Nb) ₄ C ₃ | (Nb,Zr) ₄ C ₃ | (Ti ₂ ,Nb ₂) ₃ C ₃ | (Ti ₂ ,Ta ₂) ₃ C ₃ |
| V ₂ N | Nb ₂ C | Ta ₂ N | Cr ₂ C | Hf ₃ C ₂ | (Hf ₂ V) ₂ C ₂ | (Hf ₂ Mn) ₂ C ₂ | (V ₂ Ti) ₂ C ₂ | (V ₂ Ti ₂) ₃ C ₃ | (V ₂ Nb ₂) ₃ C ₃ | (V ₂ Ta ₂) ₃ C ₃ | (Nb,Ta ₂) ₃ C ₃ |
| Cr ₂ N | Mo ₂ C | Mo _{1.5} N | Cr _{1.5} C | (Cr ₂ Ti) ₂ C ₂ | (Cr ₂ V) ₂ C ₂ | (Cr ₂ Nb) ₂ C ₂ | (Cr ₂ Ta) ₂ C ₂ | (Cr ₂ Ti ₂) ₃ C ₃ | (Cr ₂ V ₂) ₃ C ₃ | (Cr ₂ Nb ₂) ₃ C ₃ | (Cr ₂ Ta ₂) ₃ C ₃ |
| (Ti,V) ₂ N | (Ti,Nb) ₂ C | W ₂ N | W _{1.5} C | (Mo ₂ Sc) ₂ | (Mo ₂ Ti) ₂ | (Mo ₂ Zr) ₂ | (Mo ₂ Hf) ₂ | (Mo ₂ Ti ₂) ₃ C ₃ | (Mo ₂ Zr ₂) ₃ C ₃ | (Mo ₂ Hf ₂) ₃ C ₃ | (Mo ₂ V ₂) ₃ C ₃ |
| Mo ₂ N | Nb _{1.5} C | Mo _{1.5} Y _{0.5} C | | (Mo ₂ V) ₂ C ₂ | (Mo ₂ Nb) ₂ C ₂ | (Mo ₂ Ta) ₂ C ₂ | (W ₂ Ti) ₂ C ₂ | (Mo ₂ Nb ₂) ₃ C ₃ | (Mo ₂ Ta ₂) ₃ C ₃ | (W ₂ Ti ₂) ₃ C ₃ | (W ₂ Zr ₂) ₃ C ₃ |
| | | | | (W ₂ Zr) ₂ C ₂ | (W ₂ Hf) ₂ C ₂ | | | (W ₂ Hf ₂) ₃ C ₃ | | | |

M: Sc, Y, Ti, Zr, Hf, V, Nb, Ta, Cr, Mo, W, Mn

X: C, N

Theoretical Experimental Solid solution double-M Ordered double-M Ordered divacancy

Fig. 2 (a) Current members of the 2D graphene-like layered structure family.⁶ Blue shading depicts materials that are stable under ambient conditions (room temperature in air). Green-shaded materials are probably stable in air; pink-shaded ones may be stable in an inert atmosphere but are probably unstable in air. Grey shading designates 3D compounds that have been successfully exfoliated down to monolayers, as confirmed by atomic force microscopy. Reproduced from ref. 15 with permission from Springer Nature, copyright 2013. (b) MXenes can have at least four different formulas: M₂X, M₃X₂, M₄X₃, M₅X₄, where M is an early transition metal and X is carbon and/or nitrogen. They can be made in at least four different forms: mono-M elements (for example, Ti₂C and Nb₄C₃); a solid solution of at least two different M elements (for example, (Ti, V)); or ordered double-M elements, in which one transition metal occupies the perimeter layers and another fills the central M layers (for example, Mo₂Ti₂C and Mo₂Ti₂C, in which the outer M layers are Mo and the central M layers are Ti). Solid solutions on the X site produce carbonitrides. Reproduced from ref. 15 with permission from Springer Nature, copyright 2017.

microscopy techniques, such as SEM, TEM, STM, STEM, and tip-enhanced Raman spectroscopy (TERS). TERS is a variant of surface enhanced Raman spectroscopy (SERS) and it combines scanning probe microscopy and Raman spectroscopy. High spatial resolution, including nanometer spatial resolution, is possible in TERS. In addition, elemental and chemical composition analysis *via* EDX, EELS and atomic force microscopy (AFM), Raman spectroscopy, and photoluminescence (PL) spectroscopy has been widely implemented. For preference, to obtain trustworthy data, more than one characterization technique should be implemented. For example, it is essential to employ dynamic light scattering (DLS) in combination with SEM to confirm the distribution of particle sizes. On the other hand, the attributes acquired from a certain synthesis technique could be used to estimate the discrepancies between routes and to identify the best synthesis route for a particular application.

4. Properties of 2D materials

Simple ultrathin nanoparticles with significant chemical functionality and anisotropy make up two-dimensional (2D) materials. Both heat and charge transfer are restricted to one plane in such materials. They also have a huge specific surface area, a distinct optical bandgap, and strong light-matter interactions. How much of a material is exposed to the ambient surroundings is determined by its surface area (S) to volume (V) ratio ($\frac{S}{V} \propto \frac{1}{r}$). The all-surface structure of these 2D materials provides the ability to modify their characteristics by chemical functionalization: a surface treatment. Due to this, 2D materials appear to be far more reactive than their bulk equivalents.

The origin of the new properties of these 2D materials is due to the modifications of their electronic band structure and the intriguing nature of the bonds between their atoms. Due to



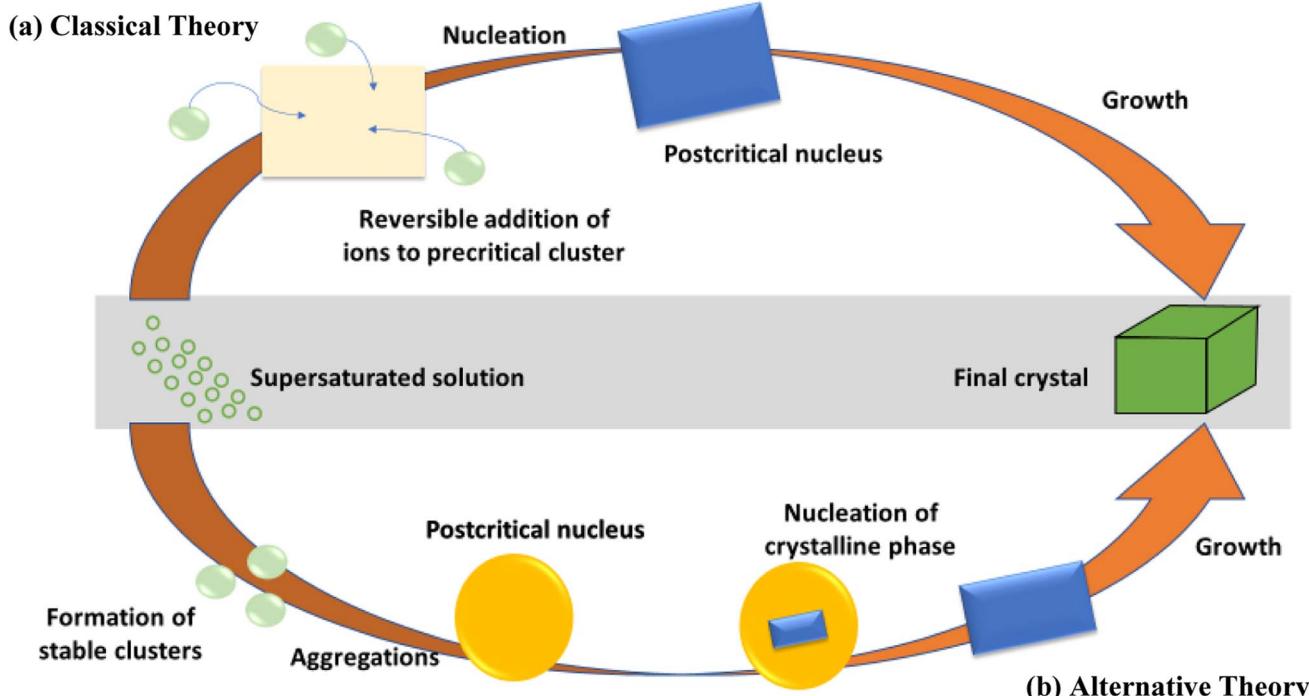


Fig. 3 Schematic sketch of conventional (a) and non-conventional (b) nucleation principles. Reproduced from ref. 17 with permission from Elsevier, copyright 2011.

strong covalent bonding, the materials provide good in-plane stability. However, the out-of-plane interactions make them excellent for monolayer isolation of a 2D single layer due to weak van der Waals interlayered interactions.^{6,22–24} Therefore, relative to bulk excitons, the bandgap and exciton binding energy will rise as a result of electron quantum confinement. Due to electron confinement and the lack of interlayer interactions, the optical and electrical characteristics of these 2D materials are entirely distinct from those of the bulk materials.^{25–27} Chemical functionalization flaws, strain,²⁸ and electric fields may all change the structural, electrical, optical, and chemical characteristics of these materials. Additionally, 2D materials inspired by graphene are receiving a lot of interest due to their unique electrical architectures.^{29–31}

In Fig. 4, we schematically highlight the electronic band parameters of a few selected 2D materials which may be important for future applications in nanodevices.

4.1 Graphene and graphene-like 2D materials

4.1.1 Graphene. Graphene is the first and most basic example of a two-dimensional crystal, or of a solid substance made up of just one layer of atoms organized in a regular honeycomb lattice structure. Because it is transparent, robust, flexible, and an excellent thermal and electrical conductor, graphene may one day be a potential material for numerous applications. It might serve as a scaffold for research into biological molecules and materials because of its high mechanical strength.

Since the publication of Geim and Novoselov's research in 2004, the area of graphene science and technology has grown

considerably. However, technological progress is dependent not just on fundamental research but also on the emergence of novel industrial-scale production methods for graphene. Even though mechanically exfoliated graphene, such as that created by the Scotch-tape method, has the greatest physical qualities, the cost of producing individual flakes using this approach prevents it from being used in bulk manufacturing. Also, graphene being a semimetal, has no energy bandgap. Thus, fabricating electronic devices that can actually turn off is a challenge. However, techniques for opening a bandgap have been developed over the years, but they resulted in sophistication at the cost of the robustness of the graphene membrane. Compared to graphene, graphene derivatives are E_g -tunable and relatively low-cost materials that involve less complex fabrication methods.³³

4.1.2 Graphene oxide (GO). It is well known that graphene oxide (GO), a sheet of oxidized graphite that is infinitely thin (atomic-scale thick), is made of carbon, hydrogen, and oxygen atoms. Regardless of the independent methods used to create it, the structure and reactivity of GO are, however, governed by the ideas and rules of organic chemistry.³⁴ The most promising technique for the large-scale manufacturing of graphene material at the current stage of graphene research is the synthesis of GO from graphite *via* the Hummers and the electrochemical methods. The most recent synthesis methods for GO have recently been properly evaluated by Brisebois and Siaj.^{35,36}

4.1.2.1 Synthesis of GO. A tried-and-true method for producing graphene-based materials is the oxidation of graphite powder to graphene oxide (GO), followed by a suitable

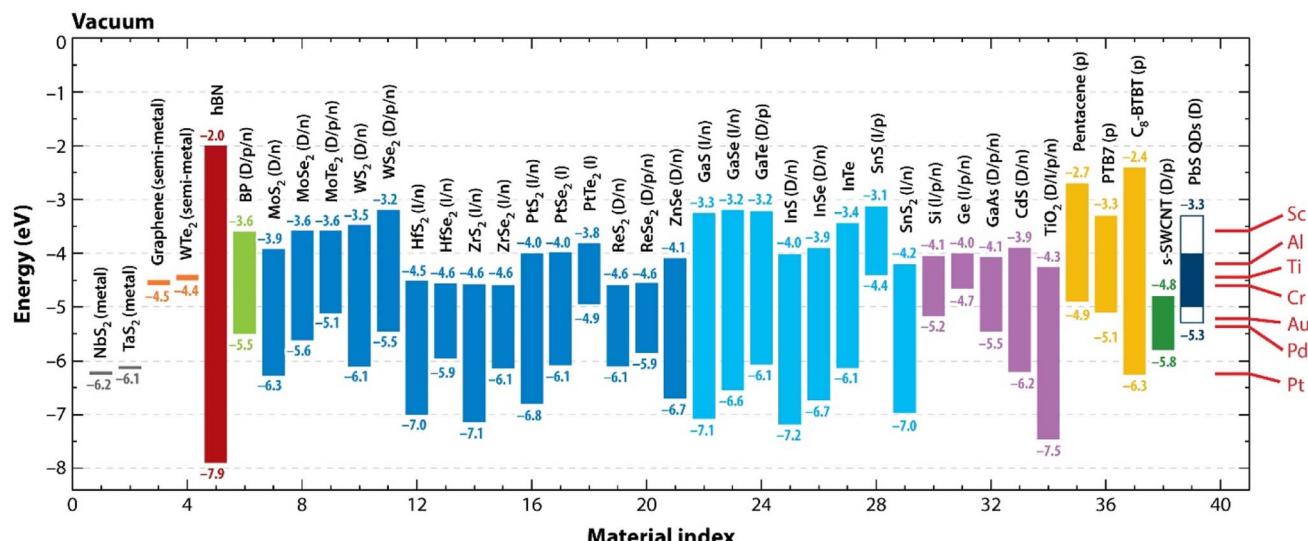


Fig. 4 Properties of the electronic bands of selected 2D materials. The positions of the valence band maxima and conduction band minima with respect to vacuum for the selected 2D monolayers and ordinary semiconductors. Metals and semimetals are covered by the work function. Materials are categorized according to colour as follows: 2D metals: dark grey (material index 1, 2); 2D semimetals: orange (3, 4); hBN: dark red (5); black phosphorus (BP): green (6); 1H transition metal dichalcogenides: blue (7–21); post-transition-metal chalcogenides: cyan (22–29); inorganic semiconductors: purple (30–34); organic semiconductors: yellow (35–37); s-SWCNT: dark green (38); PbS QDs: dark blue (39). (Right) The work functions of typical metal contacts are shown by red lines. p = mainly hole conduction; n = predominantly electron conduction; p/n = both electron and hole conduction or ambipolar conduction; D = direct bandgap; I = indirect bandgap; D/I = both direct and indirect gaps are conceivable depending on phase. If the electron affinity (CB) for monolayers is unavailable, the bulk is used to get this value. Electronic bandgaps are depicted when there are significant discrepancies between the optical and electronic bandgaps (for example, 1.8 vs. 2.4 eV for MoS₂, respectively). Reproduced from ref. 32 with permission.

chemical reduction to reduced graphene oxide (r-GO).³⁷ Many potent chemical oxidants have been regularly utilized to create graphene oxide from flaked graphite as a starting material.³⁸ The reduction of graphene oxide to compounds that resemble graphene is one of the most significant chemical transformations. In addition to its reduction, graphene oxide provides an easy method for creating functionalized graphene platelets, which may exhibit enhanced mechanical, thermal, and/or electrical characteristics.

To mention a few techniques, Tour and colleagues reported^{39,40} an improvement on Hummers' approach using ice instead of liquid water to avoid a large temperature increase and eliminating NaNO₃ to prevent the production of poisonous gases.⁴¹ Benzait *et al.* recently adopted a one-step pre-treatment ecologically friendly synthesis approach. The most recent developments in laser use in the chemical modification of GO have been emphasized by pre-treatment with a 9 : 1 mixture of concentrated H₂SO₄/H₃PO₄ (ref. 42) to provide bigger GO sheets, greater structural integrity, and a higher yield of monolayers.⁴³ Such laser-irradiated and/or chemically altered GO is primarily used in the manufacture of supercapacitors, different laser devices, including mode-locking devices, and the biomedical treatment of cancer.

Continuous efforts are being made to develop more economical methods for graphene production. Recently, Ranjan and his collaborators⁴⁴ established an inexpensive route for synthesizing GO *via* modifications to Hummers' approach. This proposed synthesis approach, however, completely eliminates

the explosive nature of the underlying reactions, yielding very good-quality GO, as confirmed by DFT, DFT-TD and Raman data.

Numerous methods have been adopted over the last decade for the production of very high-quality graphene flakes, films and several other morphologies. Among them, a noteworthy report is on the stepwise reduction of GO to r-GO containing various quantities of oxygen to better understand how the characteristics of r-GO vary when GO is reduced.⁴⁵ It is noteworthy that the controlled, step-by-step reduction of GO was accomplished using nascent hydrogen produced by the interaction of metallic zinc with HCl. Smith *et al.*⁴⁶ outlined the most recent developments in the synthesis of graphene and its derivatives and, in particular, highlighted the critical function of synthesis in modifying the physical characteristics of materials. Guex and colleagues reported^{47,48} the greatest conductivity (5 orders of magnitude to 10 S m⁻¹) measured using 4-probe sheet resistivity methodology for reduced graphene oxide. They did this by employing a quick and cheap aqueous reduction method with sodium borohydride (NaBH₄).

4.1.2.2 Optoelectronic and field effect applications of rGO. The use of GO as a precursor for the efficient, mass manufacture of graphene-based materials is widely recognized. In addition, the characteristics of rGO may be altered by adjusting the degree of reduction, the kinds of defects, doping, and functionalization.⁴⁸ Thus, optoelectronic characteristics may be tailored by controlling GO reduction using chemical or thermal methods. In fact, infrared (IR) detection with rGO is shown to be



possible⁴⁹ by time-resolved photocurrent and photo-response, with responsivity and external quantum efficiency of 4 mA W⁻¹ and 0.3%, respectively. rGO was added to a precursor solution to measure perovskite film development and its physicochemical characteristics. According to research,⁵⁰ devices with mixed-halide perovskites that have undergone rGO-20 h (reduction for 20 hours) demonstrate greater stability.

Due to its low bandgap, low surface states, dependability, natural manufacture, and high-speed detection capacity, silicon is a commonly utilized material for photodetectors in the semiconductor industry. The photocurrent exhibits a linear power dependency in the UV spectral region, indicating that the developed rGO/n-Si heterojunction can detect UV photons. The rGO/n-Si heterojunction also exhibits a quantum efficiency of 35% when illuminated by a laser diode at 685 nm. Yoon and colleagues were able to generate a largely reduced GO dispersion by shining UV light directly onto an aqueous GO dispersion.⁵¹ The performance of quantum dot light-emitting diodes (QLEDs) was then reported to have improved significantly (1.6 times) when an rGO hole injection layer (HIL) was used in place of a GO HIL.

It has been demonstrated⁵² that, when choosing the functionality of optoelectronic devices, the device design in connection with the organic-dispersed rGO in light-emitting diodes (LEDs) and photovoltaic (PV) devices must be considered. For LEDs, a layer of rGO serves as a hole-transport layer and is coated with the active components. The bulk heterojunction of the two materials that serves as an electron-acceptor in PV devices, however, uses rGO. The obtained results unequivocally demonstrate the significance of reduced graphene oxide in conjunction with the same pair of active materials in LEDs and PV systems.

Reduced graphene oxide (rGO)-based self-standing film made using a modified Hummers' process has led to the development of an optical sensor.⁵³ Additionally, the sensor is subjected to visible and near-infrared excitation; the maximum response is shown when the sensor is illuminated with a 635 nm laser at room temperature. The performance of the device as an optical sensor at low temperature using rGO technology turns out to be an intriguing feature. rGO has proven ultraviolet (UV) detection in terms of time-resolved photocurrent and photo-response.⁵⁴ In reality, it turns out that the observed behaviour is mostly a result of the competition between electron trapping by C=O groups and electron photogeneration under light radiation.

The use of rGO has been stressed because of its relative simplicity in synthesis, adjustable electrical characteristics, transparency, and capacity to interact with different photoactive surfaces to boost their efficacy. Additionally, rGO can surround the semiconductor surface and act as an encapsulant due to its huge surface area. A mini-review by Mondal *et al.*^{55,56} may eventually inspire researchers to explore new directions toward the fabrication of rGO/semiconductor nanocomposites with higher photocatalytic activity for solar-driven multifunctional applications by helping them to understand this interfacial stability between rGO and the semiconductor, electronic coupling at the heterojunction, and morphological properties of

the nanocomposites. In the article it is noted that the system is considered to be a heterogeneous catalytic system, where the phase of the catalysts differs from that of the reactants.

4.1.2.3 Application of GO in fluorescence. In contrast to inorganic semiconductor quantum dots, graphene quantum dots (GQDs) and GO are appealing fluorophores that are reasonably priced, photostable, and water soluble. They are also nontoxic, biocompatible, and ecologically benign. Interestingly, the substantial two-photon absorption cross-section of GO makes it suited to NIR biological imaging employing two-photon excitation fluorescence spectroscopy.⁵⁶ Additionally, GO and GQDs may be used as quenchers in addition to fluorophores, which leaves a lot of potential for the creation of novel fluorescent biosensors and bioimaging systems. Because it greatly increases specificity and reduces detection costs, multiplex detection is important for the practical applications of biosensors.

Biosensors that can find physiologically active substances have become extremely important in recent years from biomedical, environmental, and security perspectives. Graphene oxide and graphene quantum dots have become very adaptable platforms for the creation of biosensors.⁵⁷ The detection of Concanavalin A (ConA) using a GO/FBT (a water-soluble neutral fluorescent conjugated oligomer) hybrid is shown schematically in Fig. 5. FBT has a significant concentration of mannose side chains, which usually results in strong GO-side chain interactions. Due to fluorescence resonance energy transfer (FRET), the fluorescence of the probe was low thanks to the capacity of GO to quench fluorescence. While in the presence of the ConA, the probe would preferentially bind with ConA, which would hinder FRET and ultimately lead to efficient fluorescence recovery. The newly designed sensor could realize the visual detection of ConA or *Escherichia coli* (*E. coli*) with high sensitivity and selectivity.

Additionally, it is water soluble and possesses a sizable functionalization platform, enabling the administration of many medicines. Because of its distinctive red/near-IR emission and dependency on pH for emission, GO has been successfully used to distinguish between acidic extracellular malignant environments of HeLa and MCF-7 (apo-transferrin on two cancer cell lines) cells.⁶⁰ In fact, this strategy, along with further variation in the types of functional groups, GO flake size, and degree of oxidation, can enable this multifunctional imaging/sensing platform to be tailored to a variety of applications, such as the detection of enzymatic reactions, the detection of glucose or DNA, and microscopic optical pH sensing.

A typical enzyme found in 85% of cancers is telomerase. Single-stranded DNA (ssDNA) probes were connected to the surface of the quantum dots in order to demonstrate how the fluorescence of graphene oxide quantum dots (GOQD) changes in response to their interaction with telomerase as a diagnostic for cancer. The extension of the telomere-like probe on the surface of the quantum dots is what causes the considerable shift in emission wavelength of the fluorescence⁶¹ released by GOQD-DNA under UV illumination. *In vitro* bioimaging using decorated GO coated with polyethylene glycol (PEG) has received more attention recently as a luminous probe. Two-



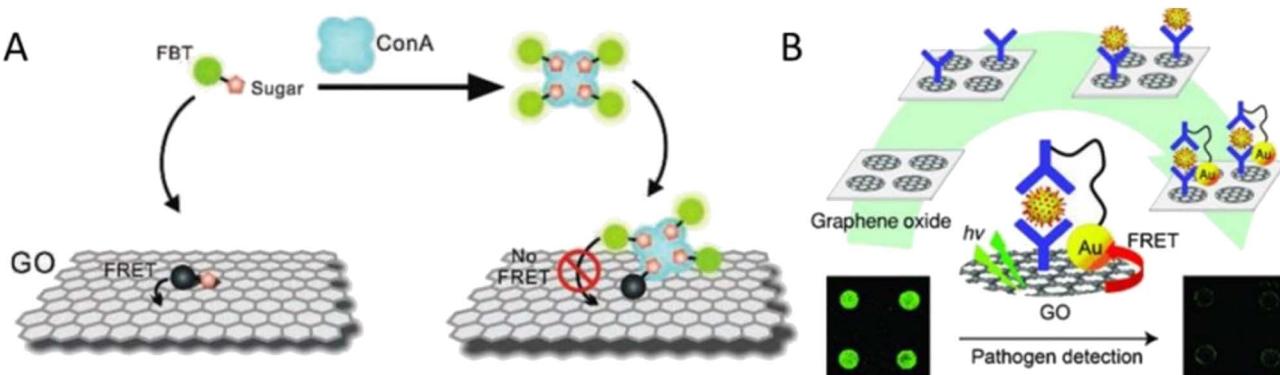


Fig. 5 (A) The GO/FBT hybrid probe's ConA detection concept (Wang *et al.* 2011). Reproduced from ref. 58 with permission from John Wiley & Sons, copyright 2011. (B) Rotavirus immuno-biosensor system based on GO for pathogen model detection (Jung *et al.* 2010). Reproduced from ref. 59 with permission from John Wiley & Sons, copyright 2010.

photon luminescence imaging of intravenously administered GO-PEG nanoparticles into mouse bodies *via* the tail vein reveals distinctive flow patterns of GO-PEG.⁶²

4.1.2.4 Challenges and outlook. When using rGO in sensors, coverage experiments must be considered in order to calculate the precise amount of rGO that is needed. In addition, reporting the number of layers of rGO is crucial for direct comparison and field repeatability. The optimization and functionalization of the nanoparticles are crucial critical elements in the use of rGO/GO in the field of tribology to provide a stable and homogeneous solution. Therefore, for a more thorough investigation and characterization of rGO/GO, the long-term stability and functioning mechanism of nano-additives is still required.

The multifunctional properties of these new 2D materials motivate further investigation and, ideally, aid in overcoming the limitations imposed on them by their application in nano-devices. More experimental investigations in the mass manufacture of pure, defect-free 2D materials at an affordable price with an appropriate bandgap should be conducted at this stage of research. Building device prototypes in this situation could benefit from robust theoretical hypotheses derived from numerous DFT simulations of 2D materials with suitable electrical composites. It is now necessary to explore novel heterostructures besides graphene in order to create faster, more compact, and intelligent nanoelectronic devices that the upcoming generation will need.

4.1.3 Silicene and germanene. The hexagonal honeycomb structure of graphene is composed of an allotrope of C that is planar. Ge, Si, and Sn, in contrast to graphene, are likely to produce sp^3 hybridization as opposed to sp^2 . Xenes are monolayers of silicon (silicene), germanium (germanene), or tin (stanene) (following the naming convention for graphene). They cannot be exfoliated from bulk material like graphene because their structures buckle, and they must be formed epitaxially on a substrate with which they typically maintain a strong connection.

Silicene⁶² is a newly discovered 2D material that, like graphene, is expected to show Dirac physics but with stronger spin-orbit interaction (SOC). The spin-orbit interaction is fairly strong in silicene and finally results in a tiny bandgap (~ 1.55

meV) opening near the Dirac point. The form of silicene with the lowest energy, which has the top and bottom Si atoms spaced vertically by around 0.44 \AA , is predicted to show a tiny amount of buckling. The inversion symmetry of the system is projected to be broken by the application of an electric field perpendicular to the plane because it will cause charge transfer between the top and bottom Si atoms, opening an energy gap.

Zhao *et al.* described the recent experimental accomplishments of silicene and its diverse prospective uses in nanoelectronics.^{62,63} Chowdhury and Jana then gave a thorough evaluation of theoretical studies on silicene.⁶² Germanene, the germanium equivalent of graphene, does not have a bandgap, but when a vertical electric field is applied, it may be employed in the channel of high-performance FETs. We attempt to highlight some significant studies on silicene and germanene in the section that follows. There is also a thorough discussion in the section on the optical and magnetic characteristics of FS silicene and germanene.⁶⁴

4.1.3.1 Synthesis and structural properties of silicene and germanene. Unlike graphene, which may also exist in FS form, silicene has only been produced on metal surfaces (in general). On conductive ceramic $\text{ZrB}_2(0001)$,⁶⁵ an iridium (Ir) (111) substrate,⁶⁶ and an Ag (111) substrate, silicene has been effectively produced.⁶⁷⁻⁷⁰ To test the stability and bonding of the monolayer, first-principles DFT simulations have been used⁷¹ to examine the electronic characteristics of a silicene monolayer on a variety of (111) semiconducting substrates, including AlAs, AlP, GaAs, GaP, ZnS, and ZnSe. With the exception of GaP, the top layer of a non-metallic substrate is subjected to p-type doping, whereas the metal substrate is subjected to n-type doping (111).

Germanene⁷² is a substance composed of a single layer of germanium atoms, which is formed on a substrate like Au (111)⁷³ under conditions of extreme vacuum and heat. Al (111), Ag (111), Cu (111), and Sb (111) are just a few of the other metallic substrate surfaces that have undergone successful attempts at deposition using germanium molecular beam epitaxy (MBE) in addition to Au (111).⁷⁴ Through first-principles research that looked at the feasibility of epitaxial germanene on



a semiconducting gallium arsenide (GaAs (0001)) substrate, its high-quality thin films offer unique electronic characteristics suited to semiconductor device applications.³⁰

4.1.3.2 Electronic properties of silicene and germanene. The primary distinction between graphene and silicene is that, in contrast to planar graphene, planar silicene is unstable. In contrast to graphene, silicon allows for the tuning of the bandgap with the application of a transverse external electric field. In contrast to the typical nonrelativistic system frequently seen in a condensed matter system, we now have another bench-top relativistic quantum system prototype in addition to graphene.

The Fermi velocity of electrons in silicene is about equal to or one order of magnitude less than that of graphene ($\sim 106 \text{ m s}^{-1}$), according to angle resolved photoemission spectroscopy (ARPES), which is frequently used to analyse the distribution of electrons in reciprocal space. In contrast to graphene, silicene exhibits a more pronounced spin-orbit interaction, which finally results in a tiny bandgap ($\sim 1.55 \text{ meV}$) opening near the Dirac point.⁷⁵ In other words, although Dirac fermions are substantial in silicene, they are massless in graphene. It should be noted that, while it contributes to the formation of a new area of study regarding the phenomenon of the quantum spin Hall effect (QSHE), this bandgap value is far from that needed from the point of view of current device applications.

Due to its mixed sp^2 – sp^3 hybridized structure, buckling also plays a significant role in the structural stability of germanene. Additionally, Nijamudheen *et al.* discovered that buckled germanene is more stable than planar germanene, in contrast to graphene.⁷⁶ Similar to graphene, germanene shows Dirac-cone-like characteristics and, in its free-standing (FS) form, has semimetallic properties.⁷⁷ Germanene has stronger surface reactivity than graphene or silicene because its buckling is higher (Table 1). Due to its buckled shape, germanene has a far easier time opening its bandgap when an electric field is applied vertically or when its sub-lattice symmetry is broken.

However, compared to graphene or silicene, the SOC value of this material is relatively high (Table 1). By including appropriate defects, such as the inclusion of adatoms, the creation of vacancies, or strain engineering, it is possible to open the bandgap at the Dirac K point for germanene in a much more practical manner than for graphene or silicene. The Fermi velocity of germanene has been determined to be two thirds that of graphene. More intriguingly, germanene has a greater inherent carrier mobility than either graphene or silicene, which may be highly advantageous for using this material in nanoelectronic devices.

4.1.3.3 Functionalization of germanene and silicene. Adsorption or doping of impure materials or the introduction of a vacuum into a pure system are common techniques to modify electronic characteristics. Both doping and vacancy inclusion might be seen as flaws in immaculate layers. Pang *et al.* used DFT to examine the structural, electrical, and magnetic aspects of 3d transition metal (TM) atom adsorbed germanene layers.⁷⁸ They said that semimetallic germanene may be converted into materials with properties resembling those of ferromagnetic

half-metals, ferromagnetic metals, non-magnetic semiconductors, and even non-magnetic metals.

The atomic radii of As and Ga are similar to that of Ge. As a result, they can be naturally favored as n (As) and p (Ga) type doping components in germanene networks. This research⁷⁹ has shown that, by selecting suitable doping elements, doping concentrations as well as doping sites, semimetallic germanene may be converted to semiconducting or metallic nature. Be-doped graphene will operate like a semiconductor with an indirect bandgap of $\sim 0.30 \text{ eV}$, according to the prediction of López-Urías *et al.*⁸⁰ The electrical and optical characteristics of the Be-doped germanene system at various concentrations were investigated by Dhar and Jana⁸¹ in response to this aspiration. Calculations of the band structure show that the semimetallic properties of germanene persist at very low Be concentrations (3.12%). However, semimetallic germanene displays semiconducting properties at modest Be concentrations (from 6.25% to 15.62%). However, the germanene structure with the highest Be content (18.75%) has metallic characteristics. The configuration with the highest bandgap, $\sim 251 \text{ meV}$, among all semiconducting configurations, has a Be concentration of 15.62%. Germanene-based field effect transistor (FET) device designs may make use of this limited and sizeable bandgap.

According to Xia *et al.*,⁸² compared to the pristine layer, there are various noticeable variations in the DOS of N_2 , CO , CO_2 , H_2O , NH_3 , NO , NO_2 , and O_2 adsorbed germanene complexes. Additionally, Gürel *et al.* asserted that germanene can develop important functions by charging and the application of an external perpendicular electric field.⁸³ Jamdagni *et al.*⁸⁴ have studied the electronic characteristics of a few vacancy-induced fluorine (F), halogen (H), or oxygen (O) functionalized germanene complexes. In order to make germanene a viable material for device applications, it is therefore conceivable to change its electrical characteristics in a variety of ways. Additionally, Wang *et al.*⁸⁵ studied the electronic characteristics of tiny organic molecules such acetone, acetonitrile, ammonia, benzene, methane, methanol, ethanol, and toluene adsorbed germanene complexes. They said that the bandgaps of these systems can be customized between 3.9

Table 1 Some important parameters of graphene, silicene and germanene. Here, ΔE denotes the difference in energies between the s orbitals and p orbitals of the last shell, and λ_{SO} is the effective spin-orbit coupling

| Parameter | Graphene | Silicene | Germanene |
|-----------------------------------------------|----------|-----------|-----------|
| Lattice constants a (Å) | 2.468 | 3.858 | 4.06 |
| Bond length (Å) | 1.424 | 2.232 | 2.342 |
| Buckling Δ_0 (Å) | 0 | 0.42–0.45 | 0.69 |
| Parameter (Å) | 2.8 | 1.6 | 1.3 |
| Hopping integral t (eV) | 0.02 | 1.9 | 3.3 |
| Energy, E_g (meV) | 1.01 | 0.65 | 0.62 |
| Fermi velocity, v_t (106 ms ⁻¹) | 0 | 0.001 | 0.007 |
| Effective electron mass m^* (m_0) | 0.001 | 3.9 | 43 |
| λ_{so} (meV) | 0.00 | 0.7 | 10.7 |
| Rashba interaction (meV) ΔE (eV) | 8.7 | 7.2 | 8.1 |



and 81.9 meV, which might be beneficial for making optoelectronic devices.

Semimetallic germanene has been shown to change into direct and indirect bandgap semiconductors by decoration with particular foreign elements (C, Si), and the bandgap values can be tuned from 26 meV to 287 meV, which may be used to create nanoelectronic tuning devices.⁸⁶ Keep in mind that group IV elements like graphene and silicene are not magnetic by nature, and neither is bare or pristine germanene. Interestingly, a pronounced magnetic moment of magnitude 4.04 μ_B is noted for one of these C-decorated systems.

Zheng *et al.*⁸⁷ applied first-principles computations to explore the electronic structure and magnetic characteristics of 2D hexagonal silicene adsorbed with H and Br atoms. They discovered that, while silicene that has been fully saturated displays nonmagnetic (NM) semiconducting behaviour, unsaturated silicene that has been only partially saturated with hydrogen or bromine exhibits localised and unpaired electrons that exhibit ferromagnetic (C) semiconducting or half-metallic behaviour, respectively.

Due to their proximity to C in the periodic table and the fact that doping significantly changes the electrical and optical characteristics of graphene, B and N are two obvious options as dopants. The electrical and vibrational characteristics of the doped system were investigated using an *ab initio* investigation of the atom adsorption and absorption of B, N, Al, and P atoms on silicene.⁸⁸

The dielectric function $\epsilon(\omega, k \rightarrow 0)$ contains both a real and an imaginary part. The imaginary part always remains positive as a function of frequency (ω), while the real part changes sign from positive to negative and cuts the frequency (energy) axis. These unique frequencies corresponding to collective excitations of electrons are responsible for the emergence of peaks in the electron energy loss spectra (EELS). In contrast to graphene, no new electron energy loss spectra (EELS) peak appears in silicene nanosheets when substituted Al, P, and Al-P atom concentrations are varied for parallel polarization, according to research on optical characteristics.⁸⁹ However, for perpendicular polarization, two small, reasonably significant, peaks appear for P doping due to buckling in the nanosheet. Using DFT, Chowdhury *et al.*⁹⁰ investigated the influence of silicene nanodisk form on its magnetic and optical characteristics (addressed later). The overall number of atoms and the number of atoms in the edges are the only two factors that set these formations apart from one another, other than shape. The configuration with the largest magnetic moment (3.969 μ_B) among them is the zigzag triangular/trigonal (ZT) ($N = 13$, Ned = 9).

The interaction of silicene with various semiconducting dichalcogenide substrates, namely MoX₂ (ref. 91 and 92) with X = S, Se, Te, has been significantly effective in controlling the electronic properties of these silicene heterolayer structures. For example, it has been demonstrated⁹² that, like FS silicene, silicene on MoTe₂ is a gapless semiconductor.

4.1.3.4 Effect of strain on silicene and germanene. The band structures of graphene and other 2D hexagonal materials may be successfully modified by mechanical forces.⁹³ According to

Mohan *et al.*,⁹⁴ 6% uniaxial compression can result in a direct bandgap of 389 meV, whereas 6% bi-axial compression can result in an indirect bandgap of 379 meV. Instead of bond length, the mechanical flexibility of silicene can be explained by changes in bond angle. In reality, flexible nanoelectronics may benefit from the better mechanical flexibility of silicene compared to that of graphene.

Another well-known silicene derivative, silicane, transitions from a semiconductor to a metal under uniform mild strain and from an indirect to direct gap transition under large strain.⁹⁵ It has been predicted⁹⁶ from first-principles calculations on the changes in band structure caused by stresses that silicene and germanene both exhibit strain-induced self-doping behaviour in the Dirac-like electronic structures. This method of doping, in contrast to doping in graphene, does not need adsorbed atoms or molecules in the nanosheets and the distance between the Dirac point and the Fermi level may be controlled by the amplitude of the strain. DFT calculations by Liu *et al.*⁹⁷ indicated that silicene retains its semimetallic character up to 7.5% tensile strain but beyond this strain, silicene transforms into a metal. DFT + Green's function and (screened) Coulomb interaction (GW) (many bodies study) formalism has been employed⁹⁸ to study the electronic and optical properties of silicane under uniform biaxial tensile strain.

4.1.3.5 Challenges and outlook. In contrast to graphene, silicene cannot develop in FS form; hence a suitable single-metal substrate is needed for its formation. Moreover, research on experimental findings related to electronic band structures and DOS will be influenced by theoretical study using a variety of substrates. In this situation, integration of a silicene nanoscale device on a silicon platform may be accomplished by growing silicene with good lattice matching on huge silicon wafers *via* buffer layers.

It naturally follows that substantial advances in the methods for synthesising hetero bilayers or multilayers of silicene will serve as a baseline for examining their enormous potential for the creation of next-generation nanoelectronic devices. It is vital to investigate various adjustments to their electronic band structure and optical characteristics when stresses, doping, and defects are present. Like other group IV elements such as graphene and silicene, bare germanene has non-magnetic characteristics. However, by adding the appropriate foreign elements, it is feasible to produce magnetism in germanene, leading to spintronic applications.

Recently, Hussain *et al.*⁹⁸ investigated the application of defective germanene nanosheets as sensors for harmful gases such as hydrogen sulfide (H₂S) and sulfur dioxide (SO₂). For future research, it could be interesting to investigate the impact of various defect types on germanene nanoribbons or nanodisks. It will also be intriguing to examine the consequences of the introduction of impurities into a hybrid structure made of germanene and other 2D materials (such as graphene or silicene).

For the use of a 2-D material in electronics devices, a finite bandgap opening is required. It should be noted that bandgaps of the order of 400 meV are needed for ordinary FET devices. As a result, a search is required to find an appropriate bandgap in



defective and adatom-decorated germanene using the interaction between SOC and substrate. From an experimental perspective, regulated nano-engineering of germanene flaws may result in the fabrication of innovative and intelligent nanodevices in the future.

Recently, transport properties along with thermoelectric features of silicene and its appropriate derivatives have been reviewed.⁹⁹ Most importantly, biosensing applications regarding DNA sequencing and detection of drugs can be noted from the changes in electronic structure or current–voltage characteristics.

4.2 Hexagonal boron nitride (h-BN)

Geim and Novoselov from Manchester University used the scientific idea of the thermodynamic instability of 2D materials, which had been foreseen by Landau and Peierls. Since the successful exfoliation of graphene from graphite using the Scotch-tape method in 2004, interest has shifted to graphene and 2D materials because of their distinctive features in contrast to those of their bulk counterparts. Hexagonal boron nitride (h-BN), a promising substitute for graphene, has been investigated in a variety of applications, including electrocatalysts, hydrogen storage, field emitters, and polymer matrix composites. This is due to its exceptional adsorption performance, high thermal conductivity, and desirable mechanical strength.^{100–102} In comparison to h-BN, boron nitride nanosheets (BNNSs) often display improved performance and more useful applications.^{103,104} Due to the partial ionic bonding (also known as lip–lip interactions) between adjacent B–N layers, the extraction of BNNSs from their bulk structures is far more difficult than it is for graphene.¹⁰⁵ Even though there have been many attempts to acquire BNNSs, effective exfoliation of BNNSs still requires a lot of work.

4.2.1 Synthesis of h-BN. Zettl *et al.* reported the first separation of free-standing h-BN nanosheets on SiO_2 in 2008, utilizing the mechanical exfoliation method.¹⁰⁶ In the years that followed, samples containing mono- and few-layered h-BN were exfoliated in order to explore their structural organization, chemical make-up, edge modification, and defect dynamics.^{107,108} Due to the size restriction of pure h-BN powder, the total diameters of the h-BN nanosheets described in this research did not often surpass a few micrometers.

In most CVD methods, the synthesis of h-BN grown on a substrate occurs. In 1995, monolayered “white graphene” h-BN nanosheets were formed on the surfaces of Ni, Pd, Ru, or Pt.¹⁰⁹ In 2002 the CVD technique utilizing B and MgO made a breakthrough in the scalable production of h-BN nanotubes.¹¹⁰ Cu and Ni films were used as substrates to create BNNSs with enormous lateral dimensions. By using plasma-assisted CVD, h-BN nanotube arrays were also produced on substrates.¹¹¹ Prior to heating, extremely disordered structures created by pre-treating boron and nitrogen precursors in a ball mill chamber helped to start the formation of h-BN nanotubes.¹¹² With the use of floating catalyst technology, the CVD process may be scaled up even further.¹¹³ In addition, “extended VLS growth” was invoked to prepare BN nanotubes using metal

boride particles serving as both catalysts for nitridation and an *in situ* reservoir of boron components^{114,115} and ZrB_2 particles.¹¹⁶ Not only can VLS pathways benefit from laser-assisted ablation and vaporization of BN raw materials,¹¹⁷ but direct growth without metal catalysts does as well.⁵⁵ Liquid boron droplets may be used as the liquid component in a VLS-analog model for the direct growth process.¹¹⁸ The self-assembly of BN nanotubes was also accomplished without the need for a catalyst using a pressured vapour condenser method.¹¹⁹ Induction thermal plasma processing using h-BN, B, or BC_4N with H_2 , N_2 , or $\text{H}_2\text{–N}_2$ has recently made it simple to produce scalable BN nanotubes at rates of $20\text{–}35\text{ g h}^{-1}$.^{120–122} In a highly polar solvent medium, such as *N*-methylpyrrolidone (NMP) or dimethylformamide (DMF), liquid-phase exfoliation of bulk BN may result in single or multilayered BNS. However, it is essential that the energy required to exfoliate BN must be akin to the solvent–BN interaction for peel-off to occur first followed by later scroll initiation.

4.2.2 Physical properties of BNNSs. BNNS structures resemble those of their parent materials. They have a layered structure made up of hexagonal lattices in which the boron and nitrogen atoms in h-BN alternate. The h-BN lattice constant in plane lattices is 2.50.¹²³ The layer stacking of the BNNS structure and hexagonal graphene differ somewhat. Fig. 6 shows the geometric structure, atomic orientation, and various morphologies. In contrast to graphene, a single layer of h-BN creates a 4.5 eV bandgap since comparable bands do not intersect one another. The bandgap of bulk h-BN has been determined experimentally to be 5.8 eV.¹²⁴

Notably, 99% transparency is displayed by 2D h-BN nanosheets at wavelengths between 250 and 900 nm. Although a significant absorption peak may be seen in the deep ultraviolet (DUV) band (200–220 nm),¹²⁵ optical absorption is rarely present. The optical bandgap of monolayer h-BN is found to be roughly 6.07 eV, in parallel with the theoretical calculations, in contrast to the bulk (bandgap 5.2–5.4 eV) (6.0 eV).¹²⁶ Due to the interlayer-interaction-induced increase in electronic band dispersion, the value for the multilayer h-BN nanostructure is found to be in the range of 5.56 to 5.92 eV, which is lower than the theoretical calculation. h-BN nanosheets may show good possibilities for usage in ultraviolet lasing, photon emission, and DUV detectors due to their direct broad bandgap and ultraviolet luminescence properties. When the h-BN photodetector was lit in a dark environment, a high on/off ratio was in fact confirmed by increasing the current by three orders of magnitude.¹²⁷

In an h-BN lattice, N atoms are expected to be replaced with O atoms, along with unpaired electrons and the accompanying paramagnetism. In fact, a strong EPR resonance signal with a predicted *g*-value of 2.0034 was found in a magnetic field of 320 mT.¹²⁸ This shows that the synthetic BNO substance contains free electrons. By carefully adjusting the h-BN thickness, it is possible to improve the optical absorption of these spiral solar cell devices by up to 90% or the absorption relative to the quantity of photoactive materials utilized, resulting in an improvement of 762%.¹²⁹ Similar to this, BNNSs are a good host



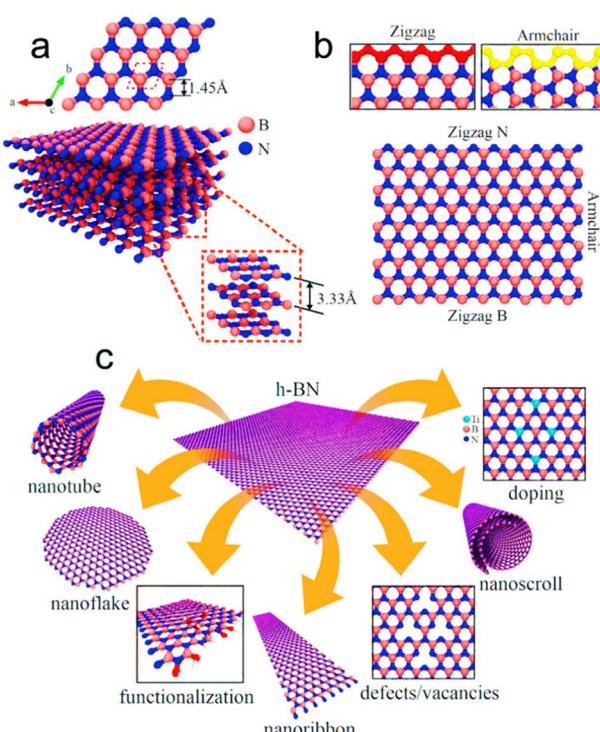


Fig. 6 (a) Geometrical structure of h-BN; the unit cell is represented by red dashed lines. (b) Display of the probable atomic distribution of B and N atoms in different orientations. (c) Illustrations showing possible configurations that can be derived using h-BN. Reproduced from ref. 125 with permission from John Wiley and Sons, copyright 2021.

for energy storage applications like hydrogen storage due to their increased surface to volume ratio.

4.2.3 Conductivity of BNNSs. h-BN nanosheets are thought to be one of the most trustworthy materials to combine with certain organic polymers for mechanical reinforcement and thermal conductivity due to their exceptional thermal conductivity.^{129,130} The thermal conductivity (κ) of monolayer h-BN is determined to be greater than $600 \text{ W m}^{-1} \text{ K}^{-1}$ at room temperature based on computational solutions of the phonon transport equation. This figure is higher than the estimated value for the bulk counterpart ($400 \text{ W m}^{-1} \text{ K}^{-1}$), as conductivity is negatively impacted by increased phonon-phonon scattering as the number of layers increases. In addition to the inherent phonon-phonon scattering, out-of-plane vibrations significantly contribute to the value for multilayers.

Despite the fact that the theoretical prediction is around $600 \text{ W m}^{-1} \text{ K}^{-1}$, the actual experimental results ($220\text{--}420 \text{ W m}^{-1} \text{ K}^{-1}$) have fallen far short of the forecast.^{123,131,132} The mono-isotopic ^{10}B and ^{11}B h-BN in-plane thermal conductivities of $585 \pm 80 \text{ W m}^{-1} \text{ K}^{-1}$ and $550 \pm 75 \text{ W m}^{-1} \text{ K}^{-1}$ measured at 300 K, respectively, are stated to be the greatest room-temperature values for h-BN to date in the literature. The observed value of $408 \pm 60 \text{ W m}^{-1} \text{ K}^{-1}$ for near-natural h-BN (78% ^{11}B) is similar to the values previously reported by Sichel *et al.*¹²³ and Jiang *et al.*¹³¹ for natural h-BN (80% ^{11}B). Thermal conductivity is lowest for isotopically disordered h-BN, estimated at $330 \pm 42 \text{ W m}^{-1} \text{ K}^{-1}$. The reported out-of-plane room-temperature (300 K) thermal conductivities (κ_z) for mono-isotopic ^{10}B , mono-isotopic ^{11}B , near-natural, and isotopically disordered h-BN crystals, respectively, are 3.5 ± 0.8 , 4.5 ± 1.4 , 3.3 ± 0.8 , and $2.3 \pm 0.5 \text{ W m}^{-1} \text{ K}^{-1}$. Fig. 7 provides a summary of the findings. All of these numbers are consistent with past natural h-BN reports in Jiang *et al.*¹³¹ and Simpson *et al.*¹³² The available literature serves as an example of how h-BN may be controlled to have high thermal conductivity, which opens up possibilities for the widespread use of h-BN as a next-generation thin-film material for thermal management, metamaterials, and metadevices.

4.2.4 Mechanical properties of BNNSs. The mechanical reaction of few-layered h-BN under indentation is considerably different from that of few-layered graphene, which is even more fascinating. The strength of h-BN nanosheets is independent of layer thickness, unlike graphene, which sees a greater than 30% reduction in mechanical strength as the number of layers grows from 1 to 8. H-BN nanosheets are preferable to graphene for a number of applications, including mechanical reinforcement, due to their rigid interlayer integrity.¹³³

Even more resistant than SiC, diamond, MgO, Mica, Si_3N_4 , *etc.*, monolayer h-BN has a Young's modulus predicted by DFT of 0.716 to 0.977 TPa ($E_{2D} = 279.2 \text{ N m}^{-1}$).¹³⁴ Although the defect density is quite high, the calculated Young's modulus values of CVD-produced h-BN films (2–5 layers) vary from 220 to 510 N m⁻¹^{135,136} while for 2D it decreased to $26.6 \pm 1.7 \text{ N m}^{-1}$ at 10% vacancies from 71.7 N m^{-1} for flawless h-BN. Thus it is evident that the decline in E_{2D} values has a linear relationship with defect concentration and it is reduced to $1154 \pm 14.8 \text{ N m}^{-1}$ at 10% vacancies. Films 1 nm thick are estimated to have a breaking strength of 8.8 N m^{-1} , breaking at deflections of 70 nm and stresses of around 221 nN. It was investigated whether the lower breaking stress and reduced stiffness are caused by defect presence or compliance at the margins.^{135,137} Once more, the Young's modulus was 0.865 TPa for tape-exfoliated h-BN monolayers with reduced defect densities. According to Cartamil-Bueno *et al.*,¹³⁸ CVD-generated suspended monolayer h-BN has a tension and Young's modulus of $48 \times 10^{-3} \text{ N m}^{-1}$ and 936 GPa, respectively, under static mechanical testing.

Young's modulus is dependent on the thickness of h-BN, just like it is with faults. For a load of 2400 N m and 0.35% strain and 37 GPa of stress, an elastic modulus of 18 000 N m⁻¹, equivalent to a Young's modulus of $1.16 \pm 0.1 \text{ TPa}$, is recorded.¹³⁹ Overall, the mechanical characteristics of h-BN are promising enough for it to be used in the creation of multifunctional fillers for nanocomposites and nanomechanical resonators.¹⁴⁰

4.2.5 Applications of BNNSs. Hybrid materials combine all the advantageous traits of the various components since h-BN nanocomposites are added to increase the toughness of the matrix. In this sense, BNNSs are sometimes stronger than other 2D materials due to their structural similarities, which include high Young's modulus and thermal conductivity.¹⁴¹ It was shown that monolayer graphene and BNNSs had plane stiffnesses of 267 and 335 N m⁻¹, respectively, and may thus be cast as appropriate fillers in polymer composites.^{142,143} It is quite



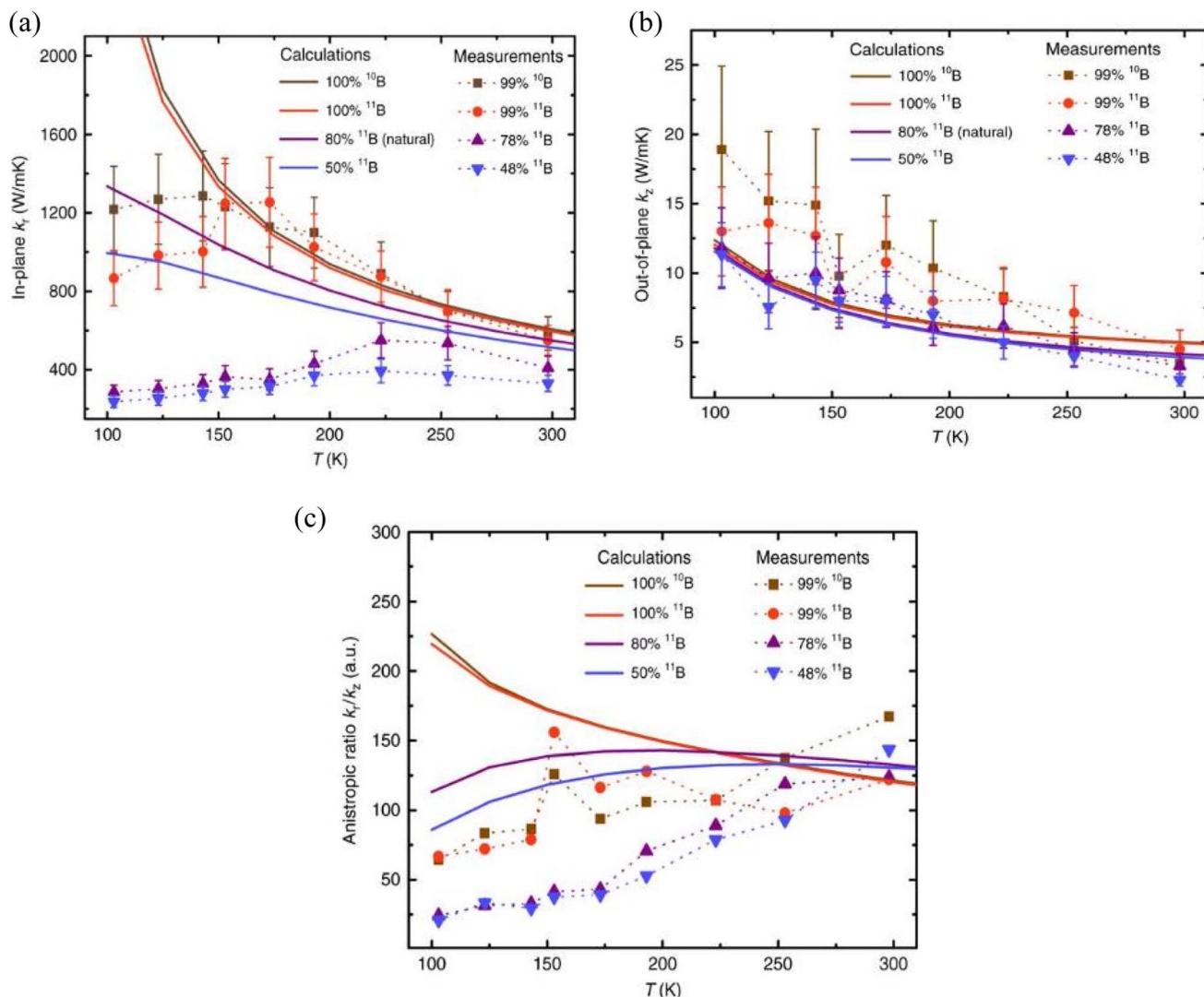


Fig. 7 Temperature-dependent thermal conductivities and anisotropic ratios of hexagonal boron nitride (h-BN) crystals, as well as comparisons with model predictions: (a) in-plane thermal conductivity κ_r , (b) out-of-plane thermal conductivity κ_z , and (c) anisotropic ratio (κ_r/κ_z) for h-BN samples with variously tuned isotope ratios. Experimental data lines serve as eye-guiding markers. The findings of the measured thermal conductivity measurements are unclear, as indicated by the error bars in (a and b). Reproduced from ref. 133 with permission from Springer Nature, copyright 2019.

likely that BNNSs would exhibit greater stiffness because of their rolled shape and structural stability in light of these findings.

Due to the widespread use of polymers as structure-reinforcing nanofillers, h-BN has demonstrated improved performance in nanocomposites because of its superior mechanical characteristics and highly anisotropic heat conductivity. Numerous studies published over the last several decades contend that polymer nanocomposites often improve performance even when reinforced by a low loading of nanofillers. For instance, Zhi *et al.*¹⁴⁴ reported that the elastic modulus and strength of polymethyl methacrylate (PMMA) were increased by 22% and 11%, respectively, when just 0.3% of BNNSs was used. As a result of the effective interaction of the matrix with the embedded BNNSs, the coefficient of thermal expansion of PMMA also noticeably decreases. Again, h-BN has

been used as a filler in other polymer matrices such as PVA,¹⁴⁵ polyurethane (TPU),¹⁴⁶ rubber,¹⁴⁷ and epoxy¹⁴⁸ to increase both the mechanical and the thermal properties.

Since h-BN is an isoelectric analogue of graphite, it has been extensively commercialized for use as Li-ion battery anodes in electrochemical energy storage applications. On the other hand, the qualities and mechanical toughness of h-insulating BN are extremely desirable for energy storage methods since they may be used as an electrode additive or as a separator. However, the usage of h-BN in supercapacitors and rechargeable lithium battery systems has been spurred by straightforward functionalization, structural modification, and incorporation into composites.

The fascinating optical properties of h-BN have encouraged its use in a multitude of applications.^{149,150} It has strong potential for nanophotonics because of its natural hyperbolic

phonon-polariton modes^{151,152} and crystallographic defects.^{153,154} Grosso *et al.*¹⁵⁵ demonstrate high single-photon count rates exceeding 7×10^6 counts per second at saturation using strain control of the emission wavelength. A sharp reduction in broad and bright autofluorescence of the as-prepared h-BN samples is observed for targeted ion beam and high-temperature annealing. Similarly, strain-controlled optical characteristics of SPE h-BN have been demonstrated.¹⁵⁶

Numerous uses for h-BN have been made possible by its intriguing optical characteristics.^{149,150} Due to its inherent hyperbolic phonon-polariton modes^{151,152} and crystallographic flaws, it offers significant promise for nanophotonics.^{153,154} Using strain control of the emission wavelength, Grosso *et al.*¹⁵⁵ establish high single-photon count rates surpassing 7×10^6 counts per second at saturation. For focused ion beam and high-temperature annealing, a dramatic decrease in wide and strong autofluorescence of the as-prepared h-BN samples is seen. Similarly, SPE h-BN has shown strain-controlled optical properties.¹⁵⁶

H_2 is an intriguing renewable energy source, but producing and storing it for use in real-world applications remains difficult tasks.¹⁵⁷ Low-dimensional h-BN materials have been shown to have high H_2 absorption capability due to partial H_2 chemisorption and greater interactions with heteropolar B–N bonds.^{158,159} A one-step, template-free reaction was used to create highly porous h-BN microbelts, which created a material with a large specific surface area ($1488 \text{ m}^2 \text{ g}^{-1}$). Additionally, BN microbelts exhibit reversible H_2 absorption from 1.6 to 2.3 wt% at 77 K and at relatively low pressure (1 MPa), according to an H_2 sorption study.¹⁶⁰

Innovative h-BN-based polymers have been specifically created for the purification of water. BNNSs are good candidates for the adsorption of contaminants, such as oil and organic solvents from heavy industries, enabling water treatment, because of their promising adsorption capabilities.^{161,162} For instance, utilizing a two-step atomic layer deposition (ALD) method, nanostructured BNNSs were created when borazine was deposited on polycarbonate and polyacrylonitrile membranes. For oil/water separation, the produced BNNSs are noteworthy due to their hydrophobic behaviour and strong lipophilicity.¹⁶³ By combining ALD-mediated h-BN deposition on a carbon nanofiber template with annealing procedures at high temperature, Weber *et al.*'s team of researchers¹⁶⁴ created BNNSs with adjustable properties. The acquired BNNSs showed admirable mechanical and adsorption capabilities (oil absorption up to 110 times their own weight in oil while resisting water) and are therefore extremely promising for depollution applications.

Additionally, h-BN nanocomposites can be utilized as drug delivery vehicles. Indeed, because of their stability, adaptability, changeable shape, low toxicity, and biodegradability, BNNSs are ranked as an excellent choice for a nanocarrier. It is possible to customize the shape of h-BN to produce the best possible drug loading and delivery.¹⁶⁵ Studying the behaviour of doxorubicin hydrochloride (DOX), an anticancer medication, loaded on BN oxide nanosheets using density functional theory and molecular dynamics also shows great potential

(BNONS).¹⁶⁶ BNNSs show a lot of potential in this regime because of their unique characteristics, such as hierarchical porosity and high specific surface area. Various aspects of h-BN nanocomposites in the respective fields of application are presented in Fig. 8.

4.2.6 Challenges and outlook. The best-quality h-BN flakes are produced *via* cost-effective mechanical and chemical exfoliation, which may produce flakes as thin as one layer. However, these processes have a very poor yield, produce tiny flakes, and lack control over the number of layers. There has not been much study of how to handle h-BN nanoscrolls in order to transfer them onto the correct substrate while constructing devices since it is challenging to isolate h-BN layers (keeping the quality and quantity intact).

By functionalizing h-BN with different doping elements and functional groups, their physical, chemical, and biological characteristics may be drastically altered. Because carbon and graphene are atomically similar, combining or integrating them might possibly alter the structure and functional properties of hBN. With tuneable mechanical, optical, and transport properties, many types of 2D heterostructures and hybridization based on graphene and h-BN nanosheets have been produced.

Again, h-BN has many distinct kinds of tiny vacancies that may be exploited as single-photon sources because of deep trap emission in the bandgap. Regarding the production of electronic devices, it is important to carefully evaluate the growth of flaws caused by sources of charge fluctuation *via* external energy.

4.3 Transition-metal dichalcogenides (TMDs)

Due to its zero bandgap and poor spin-orbit interaction, the remarkable potential of graphene cannot be realized technologically.^{33,168} As a result, the search for substitute materials with monolayer formation capability has given rise to a new field of research focused on lamellar transition-metal dichalcogenide (TMD) materials.

The family of materials known as TMDs, which consists of a transition-metal layer sandwiched between two densely packed chalcogenide (S, Se, Te) planes, has a variety of intriguing characteristics. It has the general formula MX_2 where X is a chalcogen atom of the VI A group and M is a transition element (Mo, W, V, *etc.*). TMD research has a long and successful history. Linus Pauling originally identified their structure in 1923.¹⁶⁹ About 40 of them were known to have 2D architecture by the late 1960s.^{4,5} Robert Frindt is credited with writing the initial papers on the manufacture of monolayer MoS_2 using adhesive tape in 1963,¹⁷⁰ and suspensions were first attained in 1986.¹⁷¹ Then after the discovery of graphene in 2004, research attention continued to be stimulated towards 2D layers due to their graphene-analogous properties that can be exploited in diverse fields.

4.3.1 Synthesis of TMDs. This section introduces the production processes for TMD 2D structures and the customization of their material characteristics. Currently, a variety of preparation techniques have been established to manufacture 2D TMDs with an architecture of single to few layers, including

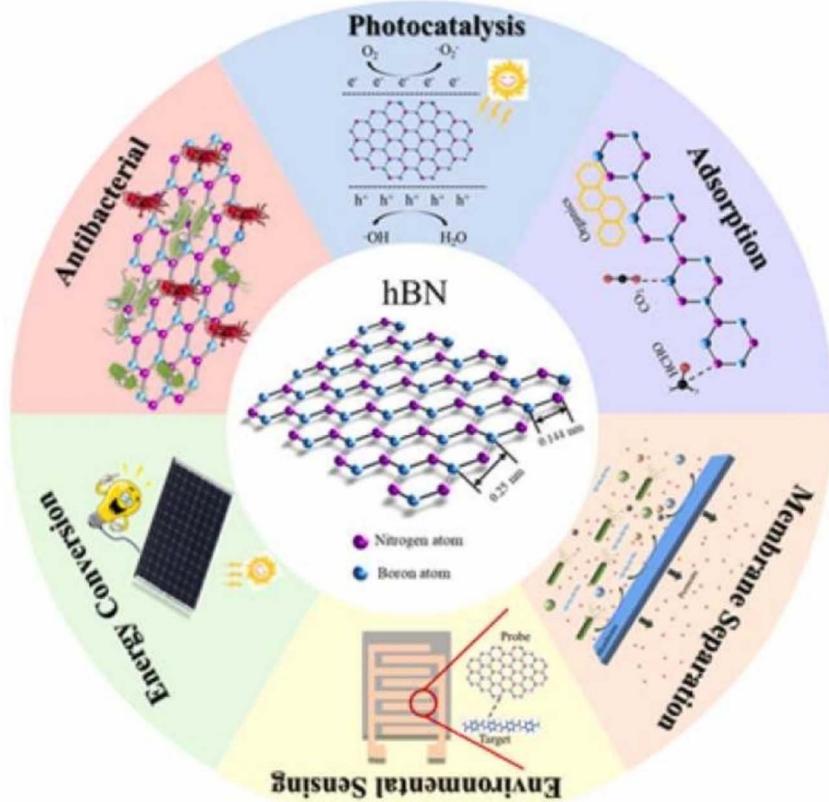


Fig. 8 The various fields of application of h-BN nanocomposites in a nutshell. Reproduced from ref. 167 with permission from Elsevier, copyright 2022.

mechanical exfoliation,^{4,172} liquid-phase exfoliation,¹⁷³ chemical exfoliation,¹⁷⁴ chemical vapor deposition,¹⁷⁵ and solvothermal methods.¹⁷⁶

4.3.1.1 Top-down methods

4.3.1.1.1 *Mechanical exfoliation.* In the mechanical exfoliation procedure, layers are separated from the bulk crystal by mechanical force. Graphene, a graphite monolayer, is where this concept originally came into being.¹⁷⁷ It is a straightforward, economical approach that works with all van der Waals materials. Furthermore, because it is produced directly from natural bulk crystals, a high-quality monolayer may be obtained.¹⁷⁸ Scotch tape, ball milling, gel-assisted exfoliation, metal-assisted exfoliation, and layer-resolved splitting (LRS) techniques are a few of the different varieties.^{179–181}

Novoselov *et al.*¹⁸² are credited with using the Scotch-tape approach to derive a TMD monolayer for the first time. By repeatedly folding and unfolding the tape, a bulk crystal of a 2D material that has been placed in the center of the tape becomes thinner. An appropriate substrate (often SiO_2 or SiC) is then covered with the thinned 2D material layers/tape, and consistent pressure is applied to improve adhesion between the substrate and the thinned 2D material layers. Once the adhesive tape has been carefully removed, monolayers of 2D material will remain on the SiO_2 substrate. This technique yields ultrathin 2D TMDs with very good crystallographic orientation and nearly

defect-free large sizes, which are suitable for electrical devices and basic research.

4.3.1.1.2 *Liquid-phase exfoliation.* Since the Scotch-tape approach cannot be scaled up, researchers are working to close this gap using the liquid exfoliation method (Fig. 9). Furthermore, because the technique can be carried out at low temperature, 2D materials may be produced on a variety of substrates. The advantages of this technology are applicable to conductive electrodes, inkjet-printed electronics, thin-film transistors, and nanocomposites.^{183–186}

Through van der Waals contact, solvent molecules with the right surface energy bond to nanosheet surfaces. Therefore, the key to increasing the degree of exfoliation is to match the surface free energy of solvent molecules and nanosheets. Currently, organic solvents like *N*-methyl-pyrrolidone (NMP) and dimethylformamide (DMF) are the most common.¹⁸⁷ Liquid exfoliation has so far been used to create a number of ultrathin 2D TMDs, including MoS_2 , WS_2 , NbSe_2 , TaSe_2 , and NiTe_2 .¹⁸⁸

As an alternative, liquid exfoliation using ultrasonication in a particular solvent might provide effective separation of bulk crystals.^{189,190} The weak van der Waals interaction might be destroyed during the sonication process. As a result, by using the right ultrasonic duration and intensity, it is possible to exfoliate bulk crystals successfully.

4.3.1.1.3 Chemical exfoliation. Liquid-phase exfoliation using organic solvents is a scalable substitute for mechanical exfoliation and enables the production of flakes with adjustable thickness. A description of solutions containing single-layer MoS₂ dates back to the 1980s,¹⁷¹ while the first report of liquid-phase exfoliation using Li intercalation was published in 1975.¹⁹² In-depth research is being done on new techniques for the liquid-phase exfoliation of TMDs employing Li intercalation.^{193,194} Exfoliation through Li intercalation has a number of drawbacks, including reported phase shifts from the semiconducting 2H to the metallic 1T phase^{194,195} and constrained sheet size. These findings show a relationship between the sheet size and significant in-plane resistance of the films.¹⁹⁴

With the use of ultrasonication in water, the chemical exfoliation process inserts intercalators into the interlayer of the bulk crystals, resulting in the effective exfoliation of bulk crystals.^{196,197} Organometallic compounds, such as butyl lithium or naphthyl sodium, are the most typical intercalators. Intercalators are initially intercalated into the interlayer of bulk TMDs in water or ethanol during the synthesis process. The bulk TMDs are then sonicated into very thin nanosheets.¹⁹⁸ Despite these achievements, TMD nanosheet wet chemical production is still in its infancy. The most difficult aspects of the synthesis are (a) finding and choosing the right metal and chalcogen reagents, (b) exercising strict control over metal oxidation states, (c) obtaining high purity and yield, and (d) comprehending how to truncate vertical development while allowing lateral expansion.¹⁹⁹

The benefit of this method would be the possibility of functionalizing the TMD nanomaterial produced during the exfoliation procedure by adding additional dispersants or

intercalants to the solution. Additionally, the final nanomaterial can be rendered water soluble depending on the kind of functionalization, enabling direct entry of these materials into biological systems.

4.3.1.2 Bottom-up methods

4.3.1.2.1 Chemical vapor deposition. Chemical vapour deposition is the process that is used most frequently to create high-quality TMDs. The early descriptions of MoS₂ synthesis relied on sulfurizing Mo that had already been placed on an appropriate substrate.^{4,101} Transition metal and chalcogenide atoms are provided *via* reaction precursors, which then react to generate 2D TMD films. The reaction product is then grown on the substrate, producing ultrathin 2D TMDs as a consequence.^{200,201} This method produces ultrathin 2D TMD nanosheets with outstanding electronic properties and high crystalline orientation. The existence of grain boundaries hinders the mobility of the films, according to research on the electrical transport of large-area devices made from comparable materials.²⁰² The desire to regulate domain orientation led to further advances, such as the use of atomically smooth *c*-plane sapphire to facilitate the epitaxial CVD growth of monolayer MoS₂.²⁰³

4.3.1.2.2 Solvothermal synthesis. Another innovation to the bottom-up approach is solvothermal synthesis. By using this technique, ultrathin 2D TMDs may be created from precursors with the help of a particular solvent and a certain reaction time.²⁰⁴ According to the literature, ultrathin MoS₂ or WS₂ nanosheets may be produced by reacting molybdic acid or tungstic acid with thiourea at 773 K for 3 hours. The advantage of this method is its ability to create ultrathin 2D TMDs in high

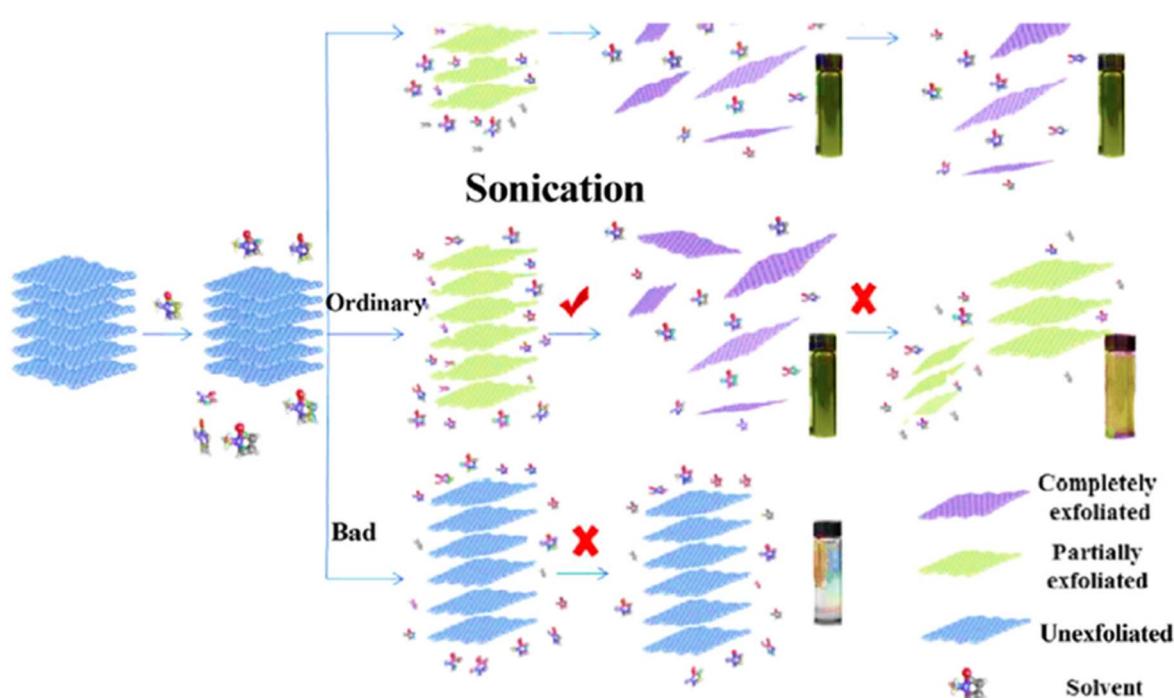


Fig. 9 A schematic illustration of the liquid-phase exfoliation method.¹⁹¹



yields at cheaper costs, which is promising for industrial applications.

4.3.1.2.3 Molecular-beam epitaxy. In order to fabricate semiconductor devices, molecular-beam epitaxy (MBE) has been used since the 1960s. An ultrahigh vacuum (UHV) is required for the deposition, which normally ranges between 10^{-8} and 10^{-12} torr.²⁰⁵ The molecular source for MBE for film growth is supplied from effusion cells by heating the solid material or supplying the gas source. No chemical reaction occurs during the production of source molecules, although one occurs on the target substrate.²⁰⁶ MBE may create a crisp, atomically thin layer between epitaxy layers or precisely dope the epitaxy layer by monitoring the shutters of individual effusion cells. UVH environments are also used in MBE to produce high-purity, defect-free films. Beginning in the 1980s, Koma synthesized monolayered MoSe₂ on a CaF₂(111) substrate.²⁰⁷ Since the doping of TMD can be achieved by introducing an extra molecular-beam source, MBE has the potential for fabricating a heterostructure with a doped layer. Fu *et al.* achieved such single-layered MoS₂ grown on h-BN.²⁰⁸ In Fig. 10, a brief précis of the literature is presented in graphical format regarding the bottom-up synthesis of TMDs.

4.3.2 Physical properties of TMDs

4.3.2.1 Crystal and electronic band structure. TMDs are layered materials in which each unit (MX₂) is made up of two atomic layers of chalcogen (X) sandwiched between a transition

metal (M) layer. The structures of 2D TMDs may be divided into trigonal prismatic (hexagonal, 2H) and octahedral types depending on how the atoms are arranged (tetragonal, 1T).²¹⁰ Each metal atom in a 2H-phase material forms two tetrahedrons with six branches in the +z and -z directions, whereas the top view reveals hexagonal symmetry (Fig. 11(a)). The chalcogen atoms in the T-phase are arranged hexagonally in the top view due to the trigonal chalcogen layer on top and a single layer with a 180° rotated structure (referred to as a trigonal antiprism) at the bottom.²¹⁰

MX₂ material possesses a stable 2H phase at ambient temperature, but a 1T phase may be produced by Li-intercalation²¹¹ or electron beam irradiation,²¹² depending on the precise arrangement of transition metals (group IV, V, VI, VII, IX, or X) and chalcogen (S, Se, or Te) components. A summary of the structure and bandgap variations of the complete class of TMD materials may be seen in Fig. 10.

Single-layer TMDs have direct bandgaps at the two inequivalent K and K' points of the Brillouin zone (BZ) for the 2H structure. The d_{x²-y²} and d_{xy} orbitals of the metal M, which combine with the p_x and p_y orbitals of the chalcogen X, are responsible for the crucial orbital character near the edge of the valence band. The edge of the conduction band, on the other hand, is created by the d_{3z²-r²} orbital of M, with assistance from the p_x and p_y orbitals of X. Multilayer compounds, as opposed to monolayer samples, are indirect gap semiconductors. The edge

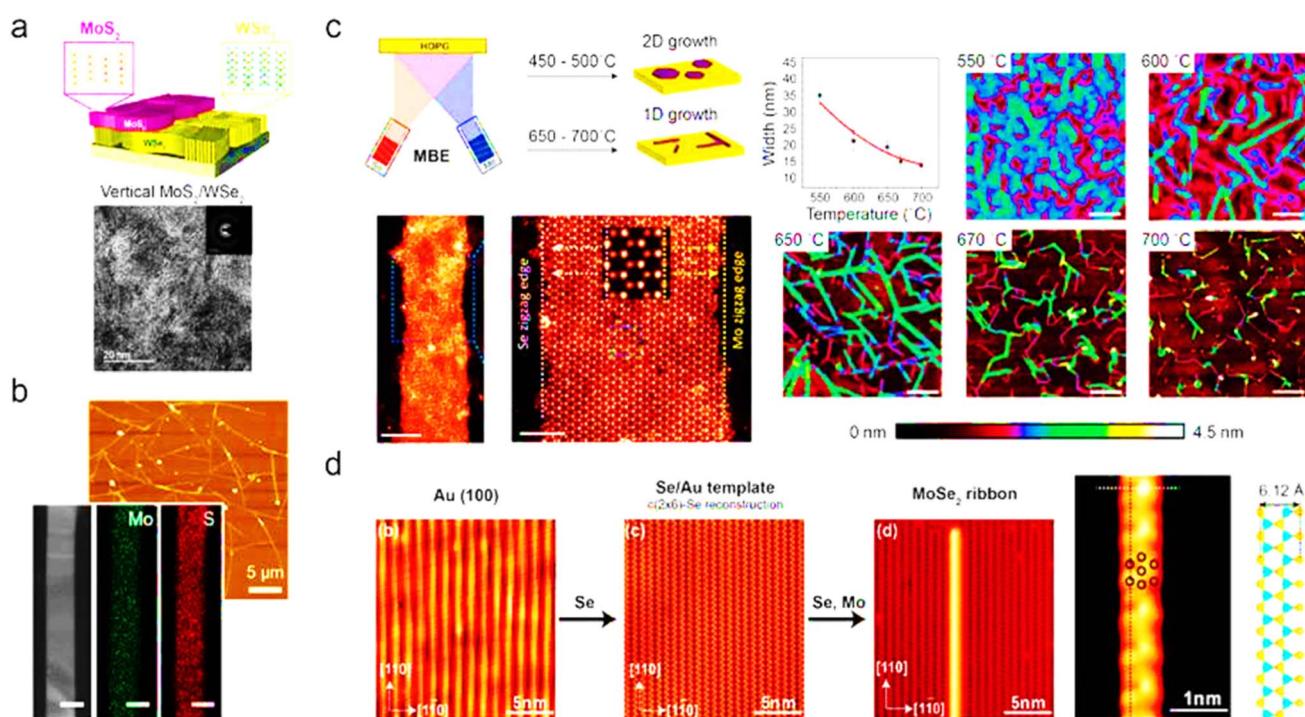


Fig. 10 TMD nanowires and nanobelts made using bottom-up techniques. (a) Through the successive development of WSe₂ and MoS₂, vertically oriented MoS₂/WSe₂ heterostructures were created. (b) By-products of an atmospheric CVD process, such as MoS₂ nanobelts. 100 nm scale bar. (c) During molecular beam epitaxy (MBE), the growth of MoSe₂ nanoribbons whose widths may be adjusted by adjusting the substrate temperature. Scale bars: 5, 2, and 200 nm (from left to right) (panels to the right). (d) Ultrahigh vacuum (UHV) chamber-based growth of ultranarrow MoSe₂ nanoribbons on Au (100) substrates with associated characterisation using high-resolution scanning tunnelling microscopy (STM) at 0.4 K. Reproduced from ref. 209 with permission from American Chemical Society, copyright 2020.



of the valence band lies at the Γ point of the BZ, with a major contribution from the $d_{3z^2-r^2}$ and p_z orbitals of the M and X atoms, respectively. It is noteworthy that the Q point is not a high-symmetry point of the BZ, for which the exact location depends on the layer number of the specific compound.

4.3.2.2 Optical and electronic properties. Compared to their bulk counterparts, single-layer TMDs have a straight bandgap with unique optical and electrical characteristics. The impact of lateral confinement on the optical and electrical characteristics of TMDs has been the subject of several studies. Bao *et al.* carried out subwavelength imaging of exciton recombination using a Campanile nano-optical probe of monolayer MoS₂.²¹³ According to their research, exciton quenching happens at about 150 nm from the edge of the layered MoS₂ crystal, indicating that crystals of lower width would have comparable impacts on their PL.²¹³ According to a recent study by Chowdhury *et al.*, MoS₂ nanoribbons with a width of less than 150 nm display PL at 660 nm, indicating a significant blue-shift in PL energy compared to 2D MoS₂ crystals.²⁰⁹ In that report, far-field PL mapping displayed a monotonic increase in PL energy as a function of decreasing nanoribbon width.

With the right material, 2D TMDs reveal a wide range of bandgaps that spans the whole visible to infrared spectrum.²¹⁴ With the exception of GaSe and ReS₂, most semiconducting 2D TMDs exhibit a direct bandgap in their monolayer topologies as opposed to an indirect bandgap in bulk.²¹⁵ As an illustration, monolayer dichalcogenides such as MoS₂, MoSe₂, (2H)-MoTe₂, WS₂, and WSe₂, all exhibit direct bandgaps with energies between 1.8 and 1.5 eV, whereas bulk phases have indirect

bandgaps with lower energy. The metallic phase and the semiconducting phase coexist in the majority of MX₂ materials.²¹⁶ Although Li-intercalation or electron beam irradiation can induce the 1T phase, the MX₂ material has a stable 2H phase at room temperature.²¹⁷ According to reports, the chemically exfoliated 1T MoS₂ phase conducts electricity 10⁷ times better than the semiconducting 2H phase.²¹⁸ When it comes to WTe₂, the 1T or 1T' phase is more stable at room temperature than the 2H phase.²¹⁹ Because of how close their cohesive energy differences are, the 2H and 1T0 phases of MoTe₂ may readily be manipulated into one another.

Since most MX₂ are devoid of dangling bonds, some of them exhibit high mobility, depending on the choice of a suitable substrate and metal contacts. For example, MoS₂ gives a mobility of 700 cm² V⁻¹ s⁻¹ on an SiO₂/Si substrate with a scandium (Sc) contact and 33–151 cm² V⁻¹ s⁻¹ on a BN/Si substrate (encapsulated) at room temperature.²²⁰

4.3.2.3 Mechanical properties. Besides being an excellent electrical transport material, the mechanical flexibility and toughness of TMDs are similar to graphene. An exceptionally high Young's modulus (Y) of $\sim 0.33 \pm 0.07$ TPa has been reported in suspended few-layered MoS₂ nanosheets.²²¹ Bertolazzi *et al.*²²² reported high in-plane stiffness and E of $\sim 180 \pm 60$ N m⁻¹ and $\sim 270 \pm 100$ GPa, respectively, for single-layered MoS₂. The Young's modulus of monolayered MoS₂ surpasses those of stainless steel (204 GPa) and graphene oxide (207 GPa), resulting from the absence of stacking faults and defect-free highly crystalline atomically thin TMDs.²²³

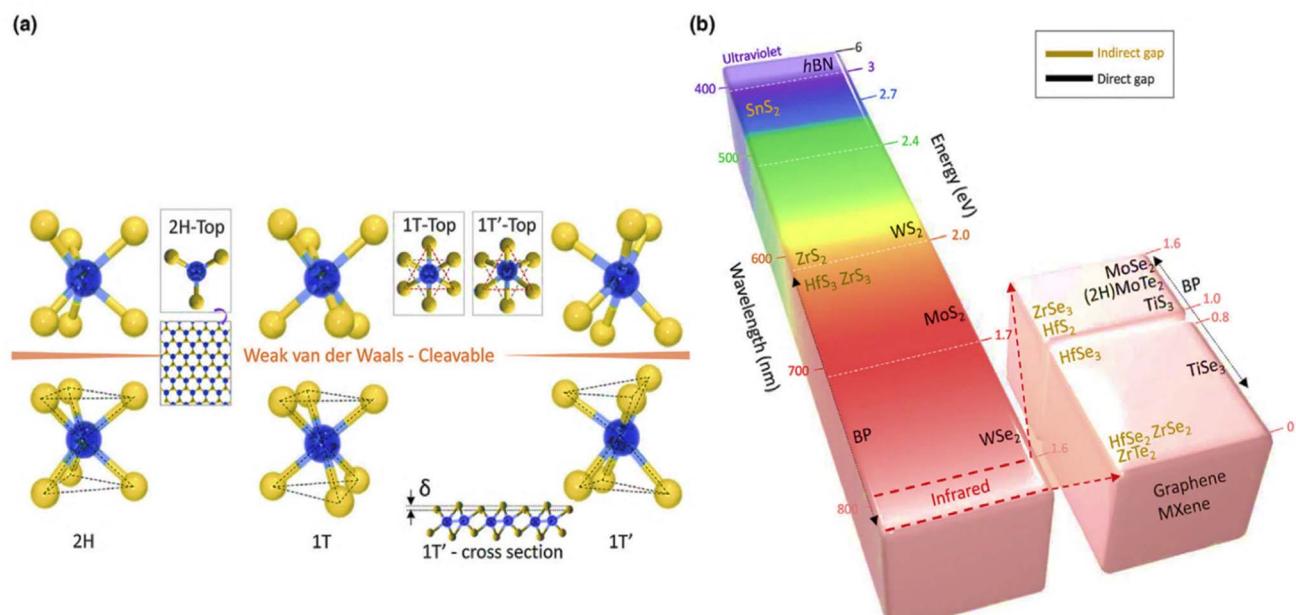


Fig. 11 (a) Typical structures of layered transition metal dichalcogenides. Layered TMD architectures with cleavable 2H, 1T, and 1T' are shown. (b) Bandgap of 2D layered materials ranging from the broad bandgap of h-BN to the zero bandgap of graphene (white colour). The colour of the column represents the associated wavelength of the bandgap; for instance, the bandgap for MoS₂ (1.8 eV) is red, whereas the bandgap for WS₂ (2.0 eV) is orange. SnS₂, ZrS₂, HfS₃, ZrSe₃, HfSe₂, ZrSe₂, and ZrTe₂ are examples of indirect materials, while direct bandgap materials are shown on the right-hand side of the column (h-BN, WS₂, MoS₂, WSe₂, MoSe₂, 2H-MoTe₂, TiS₃ and TiSe₃). Reproduced from ref. 210 with permission from Elsevier, copyright 2017.



TMDs are comparable to graphene in terms of mechanical flexibility and hardness, in addition to being an outstanding electrical transport medium. In suspended few-layered MoS₂ nanosheets, an extraordinarily high Young's modulus (Y) of $\sim 0.33 \pm 0.07$ TPa has been found.²³² For single-layered MoS₂, Bertolazzi *et al.*²²² observed high in-plane stiffness and E of $\sim 180 \pm 60$ N m⁻¹ and $\sim 270 \pm 100$ GPa, respectively. Due to the lack of stacking faults and the presence of defect-free highly crystalline atomically thin TMDs, monolayered MoS₂ has a Young's modulus that is higher than that of graphene oxide (207 GPa) or stainless steel (204 GPa).²²³

4.3.3 Functionalization of TMDs. It is important to modify the electrical characteristics of TMDs for a variety of applications by modulating mobile charge concentrations through varying degrees of functionalization, or doping. When maintaining the intrinsic TMD characteristics is crucial, noncovalent functionalization is performed because it retains the inherent features of the 2D TMD. By applying a gate voltage, it is possible to electrostatically achieve both p and n type doping.^{224,225} Another option for doping in TMDs with the right elemental selection is to substitute a transition metal or chalcogenide.^{226,227} However, by the creation of defects to varying degrees, substitutional doping disrupts the structural integrity of the TMD. TMD flakes have also been reported to be functionalized using a solution; however the functionalization procedure is often laborious and time-consuming.²²⁸ Doping using plasma causes flaws to develop and is bad for mobility.²²⁹ Therefore, research on effective doping techniques that are reliable, simple to use, and do not produce major TMD flaws is necessary. Effective n-type doping of WSe₂ has been reported utilizing both SiC thin films and potassium.²³⁰ It has been noted that Cs₂CO₃ and 1,2-dichloroethane (DCE) cause n-type doping in MoS₂.²³¹ Using NO_x and MoO₃ for p-type doping of WSe₂ and MoS₂, respectively, has been investigated.²³²

Creating chemical bonds with chemical groups that will be functionalized on the TMD surface is known as covalent modification. The functional material that is implanted onto the TMD determines how these alterations are made. For use in biological applications, TMDs can be covalently or non-covalently linked to polymers^{233,234} or smaller organic molecules.^{234,235} Another kind of modification involves adding metallic nanoparticles to the TMD sheets in order to decorate them^{236,237} and improve the electrocatalytic activity or to act as contrast agents in imaging. The behaviour of the TMD in the altered environment varies depending on the changes to the TMD and the interaction with external chemical constituents, and biological applications rely on this.

4.3.4 Applications of TMDs. Electronics, photonics, sensing, and energy storage are just a few of the applications in which the TMD family of materials in the 2D nano-architecture is appealing. Flexible nanotechnology, which is regarded as potentially ubiquitous for electronics and energy devices and stands out among the range of exceptional features in 2D materials, is of particular interest among them. Fig. 12 shows a typical representation of the opportunities for TMD in several industries.

4.3.4.1 Electrical and optoelectronics applications. High-performance 2D TFTs based on synthesized MoS₂ have now been achieved after extensive research and development. These TFTs have the high on/off current ratio and current saturation that are typical of high-quality TMDs while they function at room temperature. The achievement of electron mobility of ~ 50 cm² V⁻¹ s⁻¹ and current density of ~ 250 mA mm⁻¹ in particular raises the bar for high-performance TFTs.²¹⁰ Importantly, at a channel length of 0.5 mm and cut-off frequencies greater than 5 GHz have been attained on flexible plastic substrates.

Single-layered TMD crystals show substantial promise for use in innovative optoelectronics because of their varied exciton physics and broken in-plane inversion symmetry.²³⁸ Additionally, the substantial mechanical flexibility and electrical structural tunability of 2D TMDs support their incorporation into flexible and reconfigurable devices. 2D TMD photodetectors have high responsiveness and a low dark current, and they operate largely through the photovoltaic effect.²³⁹ Lopez-Sanchez *et al.*²⁴⁰ exhibited a single-layered MoS₂ transistor with responsivity as high as 880 A W⁻¹ when exposed to an electric field of ~ 4 V μm^{-1} .

In a significant piece of research, Mak *et al.* revealed the first 2D MoS₂ transistor working in photoconduction mode, where photoexcited carriers improved the device conductance.²⁴¹ It has been observed that single-layered WSe₂ devices with electrostatically driven p-n junctions exhibit ambipolar transport properties.^{242,243} The photodetection responsiveness of WSe₂ diodes irradiated with a 532 nm laser was demonstrated by Baugher *et al.* to be 210 mA W⁻¹.²⁴² Although these devices operate effectively at very high biases, their unoptimized device architecture and very low external quantum efficiency are a result of their low optical absorption.

4.3.4.2 Energy applications. Due to its stacked-sheet-like structure and enormous pseudo-capacitance brought on by its various Mo oxidation states (+2 to +6), MoS₂ has demonstrated a high electrical double layer capacitance (EDLC). As a result, it qualifies as a potential 2D material for supercapacitor electrodes.^{244,245} Small sheet size, limited manufacturing yield, less uncontrollability in thickness, and flaws in the synthetic processes are potential issues related to its significant use.^{178,246}

Supercapacitor electrodes made from chemically exfoliated MoS₂ nanosheets showed remarkable capacitive performance, with capacitance values ranging from 400 to 700 F cm⁻³ in a number of aqueous electrolytes.²⁴⁷ Choudhary *et al.*²⁴⁸ described the direct manufacturing on flexible substrates (copper, polyimide) of a large-scale and distinctive 3D-porous MoS₂ supercapacitor electrode. SiBs, or sodium-ion batteries, have lately been proposed as a replacement for lithium-ion batteries (LIBs). The materials for the graphite anode, however, cannot tolerate the huge size of Na⁺. Because of their roomy layered structures and good compatibility with host anode materials, TMDs like MoS₂ and WS₂ are the preferred materials.²⁴⁹

4.3.4.3 Gas sensors. Cho *et al.*²⁵⁰ actualized a gas sensing method based on charge transfer in atomically layered MoS₂



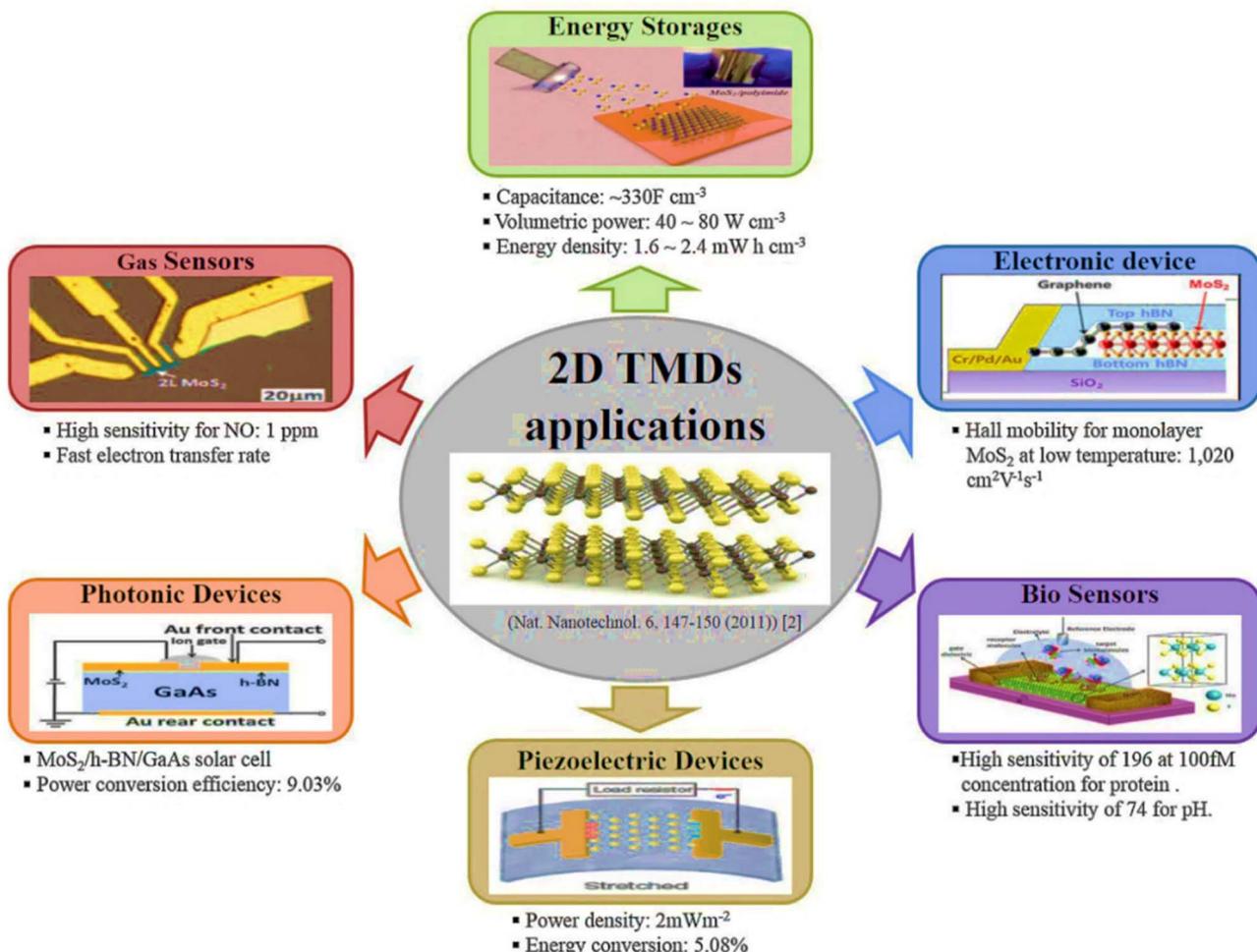


Fig. 12 Electronic, optoelectronic and energy devices based on 2D TMDs. Reproduced from ref. 210 with permission from Elsevier, copyright 2017.

employing *in situ* photoluminescence (PL). With the help of NH₃ gas and NO₂ (a p-type dopant), *in situ* PL spectra of MoS₂ (n-type dopant) were captured. Using basic principles, Yue *et al.*²⁵¹ calculated the adsorption energy and the quantity of charge transferred between monolayered MoS₂ and several gas molecules, including O₂, H₂O, NH₃, NO, NO₂, and CO. The physical absorption of these gas molecules onto MoS₂ with little charge transfer, acting to inject or withdraw electrons, was confirmed by DFT simulations.

Similar to MoS₂, the number of layers and their alignment have a significant impact on the gas sensing capability of WS₂. The relationship between the quantity of WS₂ layers and sensing effectiveness was researched by Qin *et al.*²⁵² The first demonstration of a single-layered MoSe₂-based gas sensor device is credited to Late *et al.*²⁵³ Using electron beam lithography, monolayered MoSe₂ isolated from bulk MoSe₂ was created on a SiO₂ substrate. Higher NH₃ concentrations at room temperature increased the gas response of the MoSe₂ sensor.²⁵⁴ Feng *et al.* researched gas sensors based on MoTe₂, with encouraging outcomes.²⁵⁵

4.3.5 Challenges and outlook. Despite significant advances in the synthesis of uniform, large-scale atomic layers for 2D TMDs, the quality of the material has not yet reached the highest level of homogeneity. This includes the capacity to regulate a single layer, the creation of a film free of defects, and the desired doping and alloying of TMDs. With the goal of revolutionizing electronics, optoelectronics, and energy technologies, cutting-edge synthetic techniques are now being developed in the laboratory to achieve practical applications for TMDs.

Due to their atomically layered structure, substantial surface area, and remarkable electrochemical properties when combined with surface functionality and electrical conductivity, TMDs have been suggested as potential candidates for high-efficiency energy storage. TMD materials are also thought to be one of the best options in the developing field of wearable electronics. The stretchability of TMDs should be further researched for stable operation in next-generation flexible technologies due to their wrinkled assembly.



Additionally, TMDs have generated interest as a new field of physics called “Valleytronics” due to their significant spin–orbit interactions and lack of inversion symmetry at their ultimate atomic thickness. New families of 2D materials, such as BP, silicone, and germanene, are expected to open the door to low-dimensional electronic/energy devices if their stability issues can be appropriately managed.

4.4 MXenes

With the general formula $M_{n+1}X_nT_x$ ($n = 1-4$), MXenes are categorized as a large group of two-dimensional (2D) metal carbides and nitrides, where M stands for early transition metals, X is C/N, and T_x denotes the surface termination (*i.e.*, hydroxyl, oxygen or fluorine that is produced due to immersion in an etchant).^{256,257} Since their discovery in 2011, MXenes have been the subject of extensive research due to their uncommon mechanical, electronic, and optical characteristics. In particular, sub-nanometer interlayer splits between 2D sheets in MXenes allow for quick ion intercalation and transport and are created by selectively etching, though they can be extended by combining heterostructure and appropriate 2D materials to create hybrids.^{258–261}

4.4.1 Synthesis route of MXenes. MAX-phase materials are used as precursors to achieve MXenes by selective removal of A-layer atoms, $M_{n+1}AX_n$ with $n = 1-4$; (M = early transition metal; A = A-group elements from groups 12–16 in the periodic table and X = C and/or N). More than 70 structures have already been reported, besides numerous solid solutions and ordered double transition metal structures.^{262–266} MXenes were born from an unintentional event: researchers intended to create more space for electrochemical Li intercalation/intercalation for Li-ion battery anodes, by selectively etching the A layer from an MAX-phase precursor using HF at room temperature, but, besides observing the fascinating properties of energy storage capacity, they discovered the first MXene material, Ti_3C_2 , in a large family of 2D materials.¹⁵ It has not been possible to use mechanical shearing of MAX phases to separate the $M_{n+1}X_n$ layer and make MXenes due to existence of a metallic M-A bond. Beside the first and well-known MXenes, Ti_3C_2 and Ti_2C , many more have been synthesized by selectively etching the Al layer from various MAX phases, such as Ti_2AlC , V_2AlC , Nb_2AlC , Nb_4AlC_3 , Ta_4AlC_3 , $Ti_3Al(C_{0.5}Nb_{0.5})_2$, $(Ti_{0.5}Nb_{0.5})_2AlC$, $(V_{0.5}Cr_{0.5})_3AlC_2$, $(Ti_{0.5}V_{0.5})_2AlC$, $(Ti_{0.5}V_{0.5})_3AlC_2$, or $(Nb_{0.5}V_{0.5})_4AlC_3$, using HF at room temperature (RT).^{265,267–269} Since the binding strength between various M elements and Al layers varies greatly, the etching parameters (temperature, acid concentration, and duration) must be carefully adjusted to obtain high yield and little degradation of 2D flakes in the acid.²⁷⁰ As fluoride is used to show mixed surface terminations, O, OH, and F are employed to terminate the transition metal surfaces in MXenes as they are produced in an aqueous solution.^{256,257} A combination of hydrogen and van der Waals bonds holds the multilayered materials known as etched MXenes in an HF solution together.²⁷¹ Fig. 13 depicts the synthesis pathways for MXenes.

4.4.2 Structural properties of MXenes. The structure of MXenes is roughly depicted in Fig. 14 and is a hexagonal closed packed (hcp) crystal structure with space group $P6_3/mmc$. M sites have been converted to close-packed arrangements, and X atoms are located at octahedral sites between the planes of M atoms. The ratio of M to X in the out-of-plane (*o*-MXene) and in-plane (*i*-MXene) structures is 2 : 1 or 2 : 2 and 2 : 1, respectively. The ratios are produced by the different metal lattice sites in the MXene structures, and in the case of *i*-MXene, there is at least a 0.2-size difference between M and X.^{277,297} There are theoretically expected to be at least 26 different types of *o*-MXene, and some of them, $M_2AC_2T_x$ (M = Mo, Cr, A = Ti, Sc), have already been synthesized.^{290,298} A honeycomb-like lattice is created by the hexagonal organization of the atoms in this structure, and the M atoms are located at the centers of the monoclinic ($C2/c$) or orthorhombic ($C2/m$ or $Cmcm$) structures that make up the in-plane *i*-MXene.²⁷⁷ Ordered vacancies in *i*-MXene ($W_{1.33}CT_x$ from $(W_{2/3}Sc_{1/3})_2AlC$) are produced as a consequence of the simultaneous HF etching of the A and M elements.²⁷⁹ The weak bonds between the M elements and carbon sites cause visible displacement from the M plane, and the characteristics of this structure allow for targeted etching of just the A or both the A and M from the *i*-MAX phase, *i.e.*, $Mo_{4/3}Y_{2/3}AlC$.²⁷⁸

The possibility of twinning in the M layers is made possible by the finding of a solid solution, which is composed of five M layers, $Mo_4VC_4T_x$, and differs from known MXenes. MXenes are classified as either solid solution or organized structure depending on whether one or more transition metal atoms are present in the M sites. For example, $Mo_2TiC_2T_x$ is created by sandwiching two M layers together, and $Mo_2TiC_3T_x$ is created by sandwiching one M layer between two M layers. One or three M layers could theoretically be squeezed between M layers (bottom row in Fig. 14), resulting in the formation of an M_5X_4 structure.²⁹⁹

4.4.3 Electronic properties of MXenes. MXenes are a strong option for a number of uses because of their high electrical conductivity, including electrodes for optoelectronic devices and transparent conductive films, printed electronics, sensors, and electromagnetic interference shielding.^{15,300,301} The nature of the transition metal layer M, X, and T_x , which is feasible for rich transition metal chemistry, has been demonstrated by computational studies to cause the electronic properties of MXenes to shift from metallic to semiconductor and superconducting nature.^{257,302–308} Due to the transition metal free electrons acting as carriers, all bare MXenes are expected to be metallic conductors,^{302,309} but they can be electronically tuned by gradually changing the Fermi level due to surface termination.³¹⁰ However, the transition metal and MXene structure cause the resistivity to have a negative temperature dependence, which causes MXenes to act like semiconductors. An illustration of this is shown in Fig. 15(a), where $Ti_3C_2T_x$ exhibits metallic conductivity and $Mo_2TiC_2T_x$ exhibits semiconductor-like behavior when Ti layers are replaced with Mo layers. This could be experimentally accomplished to synthesize and characterize MXene semiconductors with superior broad bandgaps, like Sc_2CT_x , Cr_2CT_x , or $Cr_2TiC_2T_x$.³⁰⁸ The density of states (DOS)



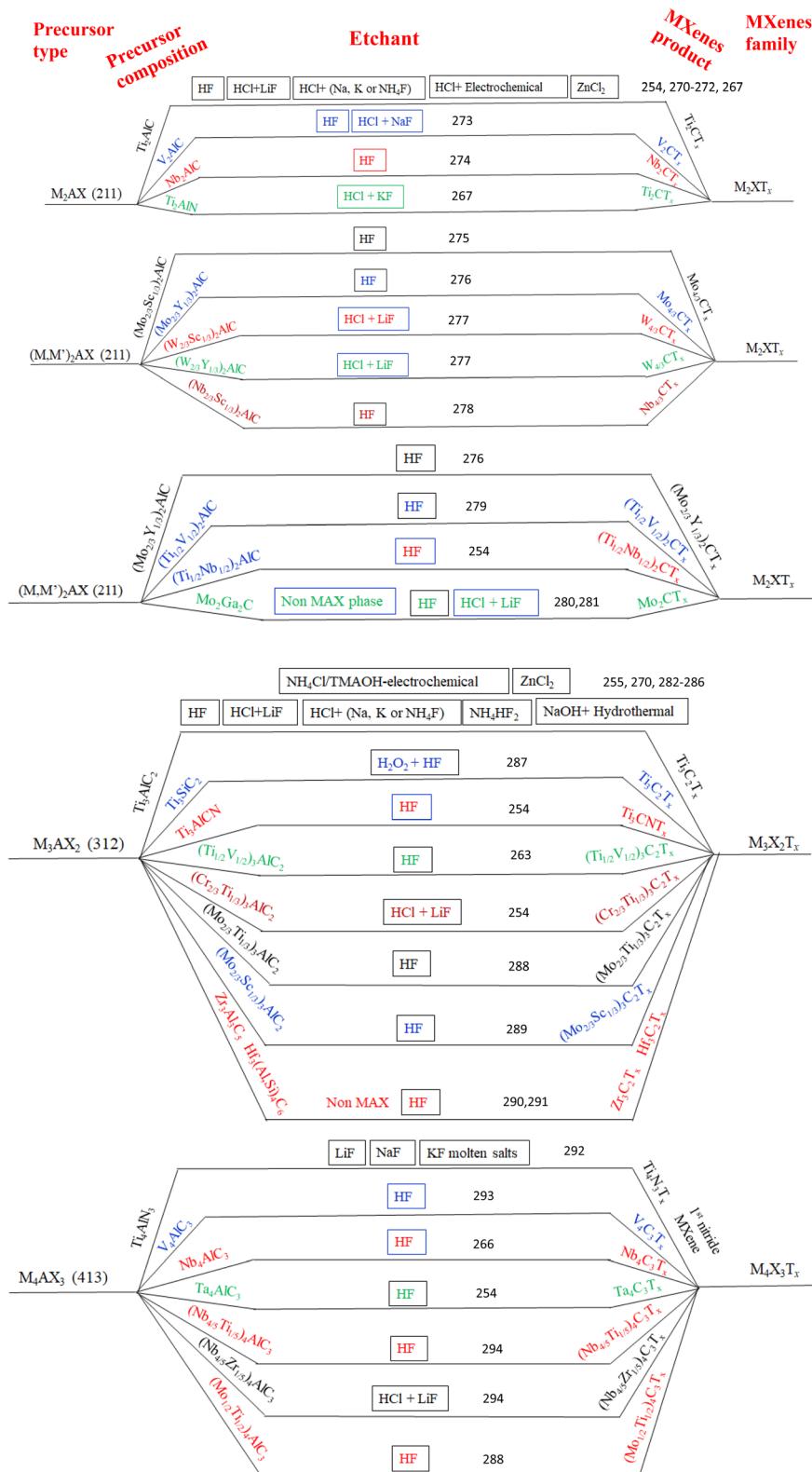


Fig. 13 Existing MXene family with their precursors and etching route.

is greatly modified by a change in the M layer in MXenes. However, by varying the outer M layer of MXenes, attractive magnetic properties of the MXenes, such as antiferromagnetic

characteristics, can be anticipated.³¹¹ The middle layer of the *o*-MXenes is expected to contain nitrides and Mn, which will give them a ferromagnetic nature.³¹¹ The magnetic glass transition



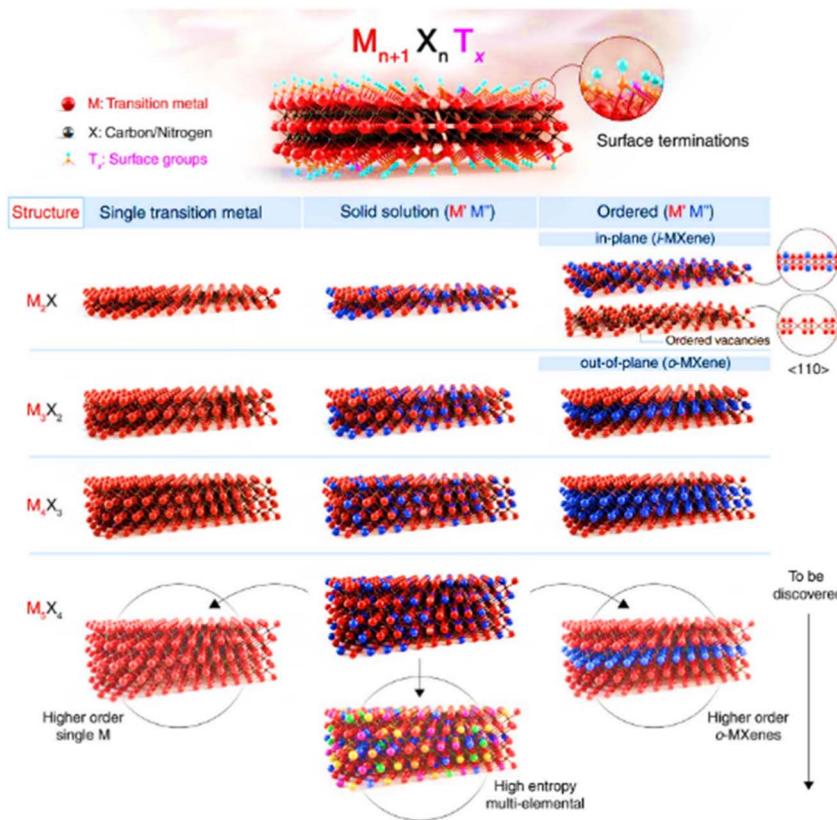


Fig. 14 The general formula of 2D MXenes is $M_{n+1}X_nT_x$ where M is an early transition metal, X is carbon and/or nitrogen, and T_x represents surface terminations of the outer metal layers. n can take values from 1 to 4, subject to the number of transition metal layers, *i.e.*, Ti_2CT_x ($n = 1$), $Ti_3C_2T_x$ ($n = 2$), $Nb_4C_3T_x$ ($n = 3$), and $(Mo, V)_5C_4T_x$ ($n = 4$). Reproduced from ref. 291 with permission from Elsevier, copyright 2017.

temperature for $Cr_2TiC_2T_x$ has been observed to be between 30 and 35 K.³¹² Furthermore, theoretical hypotheses continue to serve as a guide for more desirable and potential structures and compositions. Because the outer transition metals in MXenes are more essential for electronic properties than the core metal, surface functionalization has a significant impact on the electronic structure of the surface metal, as shown in Fig. 15(b). Due to surface functionalization, when an electron moves from a transition metal to an electronegative surface, the DOS of transition metals is greatly reduced.^{307,308,313} Because they can only accept one electron from the surface metal, OH- and F- terminations are expected to have a comparable effect on the electronic properties of MXenes, whereas O-termination may have a significant impact because it can accept two electrons.³⁰⁸

In Fig. 15(c), where they are used as transparent conductive electrodes (TCEs) in OLEDs³¹⁴ and photonic diodes, the work function (ϕ) of MXenes is highly tunable using an appropriate combination of transition metals, X elements, and surface termination.³¹⁵ For instance, a $Ti_3C_2T_x$ TCE in an OLED and the incorporation of a TiO_2 electron transport layer in a perovskite solar cell improve the external quantum efficiency by 28.5% and 5%, respectively, over the original cell and the state-of-the-art commercial OLEDs.³¹⁶ As the oxygen termination increases, OH always decreases, but F varies with the materials due to the influence of the surface dipole as compared to the naked

surface.³¹⁷ Fig. 15(c) shows the expected ultralow work function of hydroxyl (OH) surface terminated MXenes, which is attractive for emitter cathode field effect transistors (FETs). The lowest work function is 1.6 eV for $Sc_2C(OH)_2$. The work function is defined as the difference between the Fermi level and the vacuum level; shifting the Fermi level to a lower level has the effect of increasing the value of the work function. In general, the work functions for the O- and F-terminations show higher values than OH-. However, even compared to bare MXenes, where the negative surface dipole moment is actually operative, the value of the work function in the case of OH- is significantly lower.³¹⁸ The controlling surface, which is extremely effective for the TCE, can be used to achieve a high value of 5.1 eV and large electrical conductivity of $11\,670\,S\,cm^{-1}$.³¹⁹ Ti_3C_2 is discovered to have a value of 4.60 eV, which makes it a better contact than ZnO or SnO to form n-type and p-type thin-film transistors, respectively.³²⁰

According to the definition of a topological insulator (TI), electrons with opposing spins propagate in opposite paths after low-dissipation electron transport. It is anticipated that the presence of heavy elements in 2D materials will result in TIs, in which spin-orbit coupling (SOC) has a significant impact on the electrical structure. As a result, MXenes containing strong 4D and 5D transition metals like Mo, W, Zr, or Hf may manifest as 2D TIs. It is expected that few MXenes will

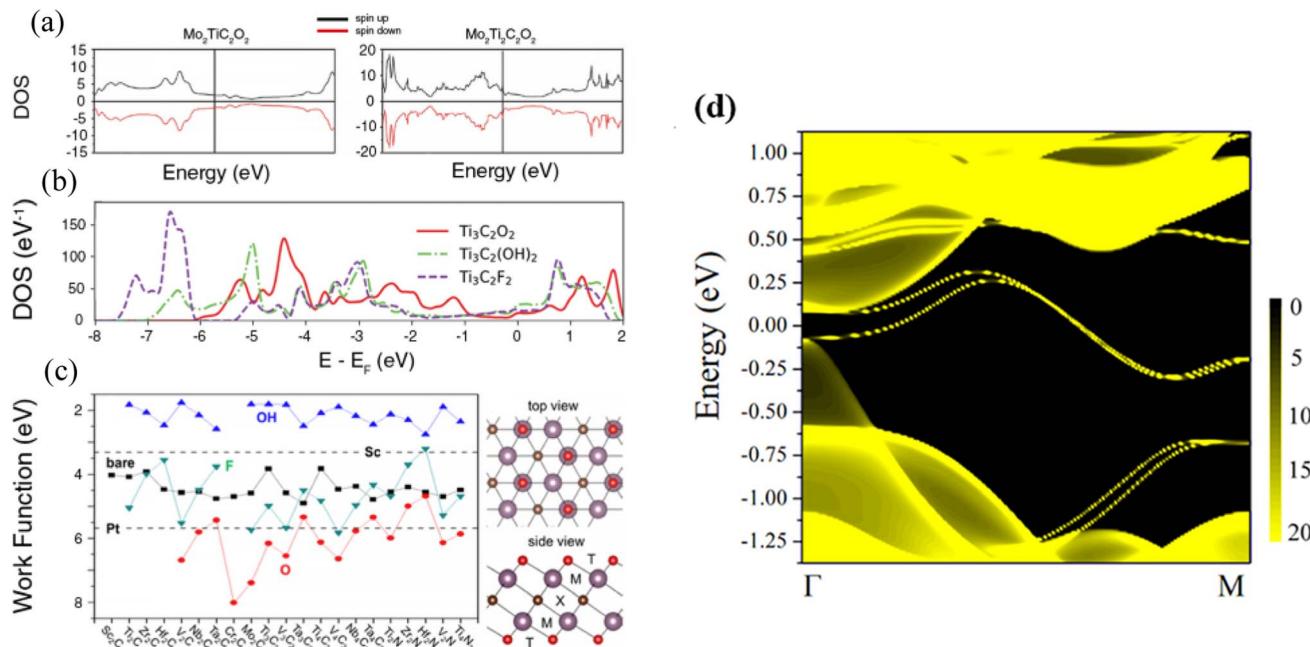


Fig. 15 (a) TDOS of $\text{Mo}_2\text{TiC}_2\text{O}_2$ and $\text{Mo}_2\text{Ti}_2\text{C}_2\text{O}_2$ indicates the effect of MXene structure. (b) DOS of Ti_3C_2 , $\text{Ti}_3\text{C}_2\text{O}_2$, $\text{Ti}_3\text{C}_2(\text{OH})_2$, and $\text{Ti}_3\text{C}_2\text{F}_2$ show how the electronic properties of MXenes are affected by surface chemistry. Reproduced from ref. 314 and 321 with permission from John Wiley and Sons, copyright 2018. (c) The work function of various MXenes is dependent on surfactance. (d) $\text{Mo}_2\text{HfC}_2\text{O}_2$ local DOS with energy and momentum dependence, where the edge states link the bulk valence and conduction bands at the M point by forming a single Dirac cone.

be TIs. 2D TI behavior has been found in MXenes double ordered transition metal carbides in $\text{M}_2\text{MC}_2\text{O}_2$ ($\text{M} = \text{Mo, W}$ and $\text{M} = \text{Ti, Zr, Hf}$) with O-termination.^{321,322} Fig. 15(d) shows an illustration of the energy-momentum local DOS of $\text{Mo}_2\text{-HfC}_2\text{O}_2$, where a Dirac cone is created by the edge states at the M point and attaches the bulk valence and conduction bands to safeguard the topological character. Recently, TI behavior has been revealed in a nitride-based MXene, $\text{Ti}_3\text{N}_2\text{F}_2$. The TIs in MXenes have typically only been studied using complete O- or F-termination up until this point, and there has not been a comprehensive report on how surface termination affects the behavior of MXene TIs. Additionally, the behavior of MXenes is only anticipated; none of them has yet undergone experimental observation.³²³

4.4.4 Optical properties. Due to their nanoscale particle size range, MXenes exhibit a variety of light interactions, making them attractive for use in optoelectronic devices. The color of MXenes is an effective way to gauge quality and degree of deviation from the desired color during the synthesis. This is also an indication of MXene degradation, in which the electron density changes as the M site and structure change, which ultimately affects the material color. The hue of MXenes in solution and films is outlined in Table 2. The peak wavelength (max) is listed in Table 2, where it shifts to a higher frequency as Ti_2C and Mo_2C undergo structural changes to become Ti_3C_2 and Mo_2TiC_2 , respectively.³²⁴ MXene materials exhibit moderate transparency in the visible range according to the transmittance curve, but a distinguishing characteristic has been noted in the near-infrared region. For Mo_2C , Mo_2TiC_2 , $\text{Mo}_2\text{Ti}_2\text{C}_3$, and Nb_2C , the transmittance increases as the wavelength increases;

however, for V_2C , Ti_2C , and Ti_3C_2 , the transmittance declines (Fig. 16).³²⁴

4.4.5 Mechanical properties. Although the experimental investigation of MXenes is still in its early stages,³²⁵ it is anticipated that their high elastic stiffness will be comparable to that of their bulk carbide counterparts.³²⁶ Fig. 17(a) displays the theoretically computed elastic constants for MXenes.³²⁷ Here, the structure of C_{11} clearly affects its value, with M_2X having a greater value than M_3X_2 or M_4X_3 . For Ti_2C , a comparable comparison has been demonstrated (Fig. 17(a)).¹⁵ It is observed that 40% more C_{11} values are shown in the MXene phases than that of their precursor MAX phases. The elastic constants of single-layered graphene are noted to be considerably higher than those of MXenes; however, they are found to be better for multilayered MXenes of similar thickness.³²⁷

Table 2 The peak of the extinction spectra and the hue of solutions and films for various MXene materials. Adopted with consent from ref. 324

| | Solution | Film | λ_{max} |
|------------------------------------|--------------|-------------------|------------------------|
| Ti_2C | Wine | Green | 542 |
| Ti_3C_2 | Forest green | Dark purple | 800 |
| Nb_2C | Blue hue | Yellow | 915 |
| Nb_3C_2 | Gray | Blue | No peak |
| V_2C | Green-blue | Bronze | No peak |
| Mo_2C | Brown | Green | 450 |
| Mo_2TiC_2 | Orange-brown | Light blue-silver | 476 |
| $\text{Mo}_2\text{Ti}_2\text{C}_3$ | Grey | Dark green-grey | No peak |
| Ta_4C_3 | Brown | Sliver-grey | No peak |



The stress-strain curves of various MXenes are shown in Fig. 17(b).

Fig. 18(a-h) show how the AFM nanoindentation experiments were explained in terms of the monolayer of $\text{Nb}_4\text{C}_3\text{T}_x$.³²⁸ It provides noncatastrophic fracture with a 202 nN maximal load. For monolayered $\text{Nb}_4\text{C}_3\text{T}_x$ flakes, the typical 2D elastic modulus and pre-stress level are determined to be 486 to 18 N m⁻¹ and 0.06 to 0.32 N m⁻¹, respectively. A comparison of different 2D materials is shown in Fig. 18(i), where these materials exhibit greater values than those of Bi_2Se_3 ,³²⁹ InSe ,³³⁰ WSe_2 ,³³¹ MoS_2 (ref. 222) or WS_2 ,³³² but still fall short of those of graphene³³³ or h-BN.³³⁴ It is anticipated that nitride-based MXenes will have a greater in-plane Young's modulus than carbide-based MXenes.³³⁵

4.4.6 Radiation shielding and antenna applications.

MXenes are more effective at shielding against electromagnetic interference (EMI) due to their high metallic conductivity and radiation effectiveness. Different MXenes have been used to accomplish EMI shielding, which is highly dependent on their

structure and composition. Fig. 19(a) shows how the thickness affects the EMI shielding of various MXenes and standard materials. As can be seen, $\text{Ti}_3\text{C}_2\text{T}_x$ shows EMI shielding efficacy of 50 dB (99.99% protection) at 1 to 2 μm thickness and 92 dB at 45 μm thickness.³³⁶ At 16.4 GHz, a 5.5 m thick $\text{Ti}_3\text{C}_2\text{T}_x$ reinforcement antenna produced by spray-coating from aqueous solution exhibits 99% radiation efficacy, which is very comparable to a typical 35 m-thick copper patch antenna at around 15% of its thickness and 7% of the weight of copper.³³⁷ The flexibility, scalability, and simplicity of solution processing combined with the adaptability of MXene antennas make MXene an excellent material for RF components that are integrated into a variety of flexible electronic devices. No central frequency change is visible in $\text{Ti}_3\text{C}_2\text{T}_x$ after various bending cycles for various thicknesses.³³⁷

The EMI shielding efficiency of Ti-based MXene is greater than that of other MXene materials. Additionally, Fig. 19(c) and (d) illustrate the EMI shielding characteristics of some solid-solution MXenes, demonstrating how the chemical composition can be adjusted to alter this characteristic.³³⁸ Due to its increasing absorption, thermal annealing of Ti_3CNT_x results in a greater shielding efficiency than $\text{Ti}_3\text{C}_2\text{T}_x$.³³⁹ Fig. 19(d) illustrates a contrast in the annealing temperatures for Ti_3CNT_x and $\text{Ti}_3\text{C}_2\text{T}_x$. The value of total shielding efficiency of 40 m-thick Ti_3CNT_x is raised to 116 dB for an annealing temperature of 350 °C, indicating that the annealing temperature has a significant impact on EMI SI.

The samples are annealed at 800 °C for two hours in an argon environment in Fig. 20(a).³⁴⁰ The EMI SE value of the annealed sample is greater than those of clean 60 and 70 wt% samples but less than those of 80 and 90 wt% samples. By foaming the porous structure, the EMI performance of 6 m-thick MXene can be raised to 70 dB from its initial value of 53 dB.³⁴¹

4.4.7 Energy storage applications of MXenes. Due to intense industrial needs, there has been a lot of interest in electrochemical energy storage at high charge-discharge rates. Because of its greater specific surface area, weaker interlamellar forces, and open structure, MXene has an energy storage

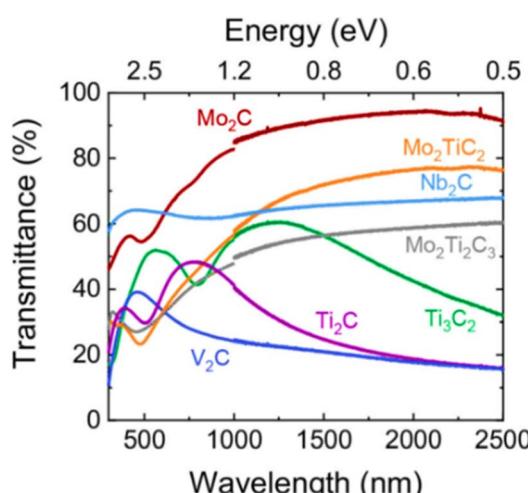


Fig. 16 Transmittance profiles for various MXene materials. Adopted with consent from ref. 324.

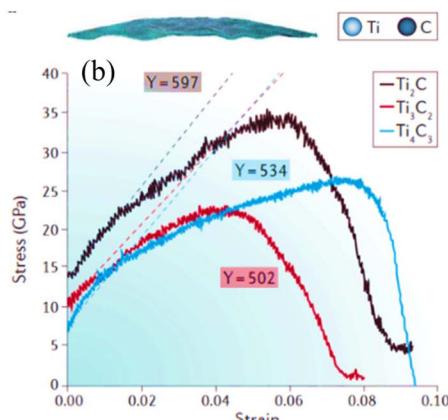
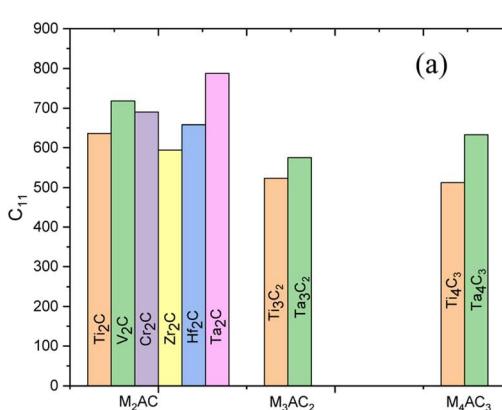


Fig. 17 (a) Calculated elastic constant values for various MXenes. (b) MXene stress-strain curves for Ti_2C , Ti_3C_2 , Ti_4C_3 . Reproduced from ref. 15 with permission from Springer Nature, copyright 2017.



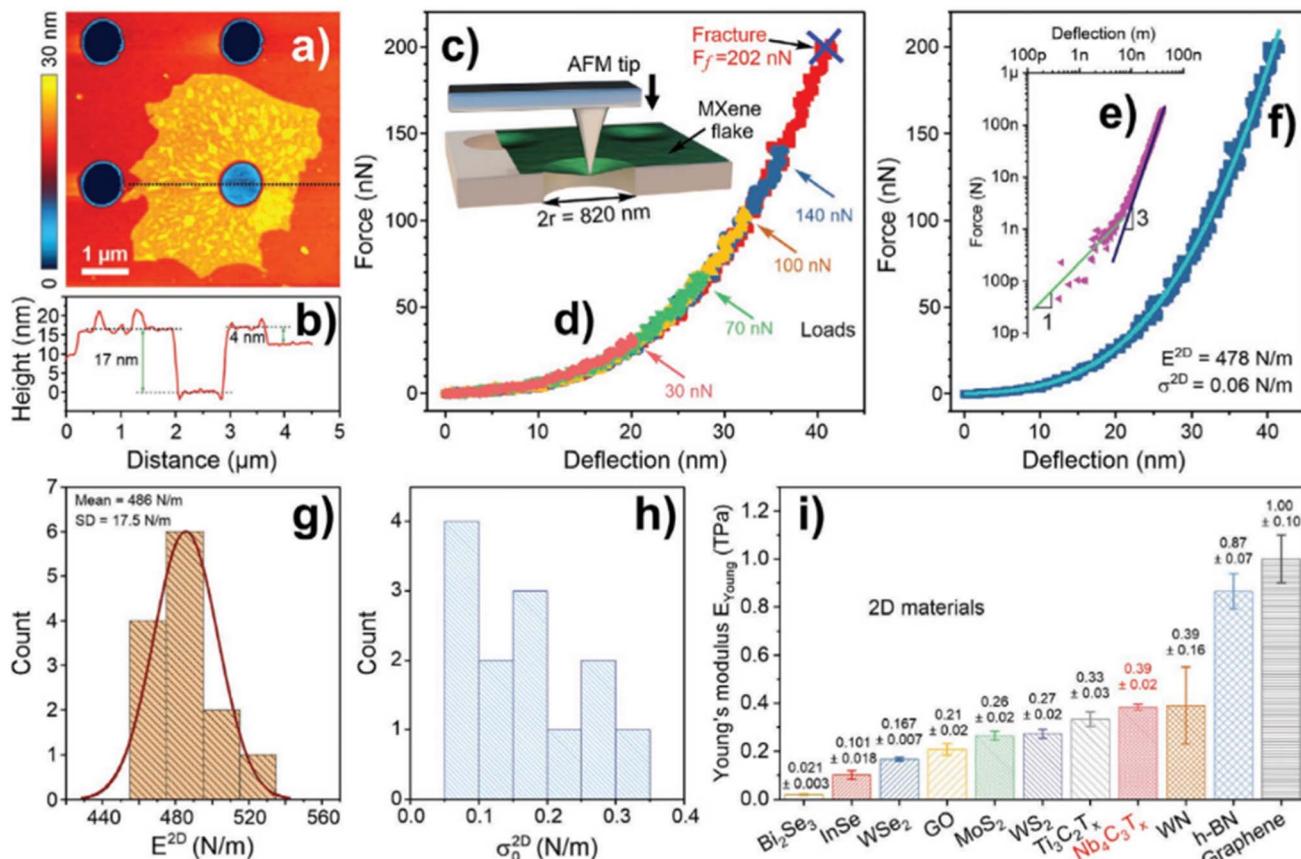


Fig. 18 Nb₄C₃T_x indentation test findings for Nb₄C₃T_x: (a) AFM picture. (b) Measurement of the AFM height profile. (c) The tip of the AFM on the suspended membrane. (d) The force–deflection curve for various weights. (e) The loading curve for the Nb₄C₃T_x membrane. (f) The loading curve with least squares fit to the experimental data. (g) Distribution of elastic elasticity for 1L Nb₄C₃T_x membranes. (h) Pre-stress conditions for a monolayered membrane. (i) Comparative chart Young's modulus for various 2D materials. Reproduced from ref. 328 with permission from John Wiley and Sons, copyright 2020.

capability that is numerous orders higher than that of its pristine material. MXenes are ideal materials for lithium-ion batteries (LiBs) because of their 2D layers of M_{n+1}X_nT_x, which allow for the accommodation of varying ion sizes. In comparison to Ti₂AlC, Ti₂C exhibits a storage capability that is about 5 times greater,³⁴² where the formula weight, particle morphology, and surface termination are the primary determinants of the property. Compared to M₃X₂ and M₄X₃, M₂X has a greater storage capacity per gram due to ion penetration that only occurs between the MXene layers.¹⁵ For Li⁺ absorption, for example, Ti₂CT_x offers more than 1.5 times the gravimetric capability of Ti₃C₂T_x.³⁴² Nb₂CT_x has greater Li⁺ storage capacity than Ti₂CT_x, despite being heavier, thanks to the low Li diffusion barrier of the MXene.²⁶⁹ Additionally, milled V₂AlC has smaller particulate sizes than unmilled V₂AlC in V₂CT_x, which makes it easier for Li to diffuse into the MXene layer and ultimately boosts the energy storage capacity.²⁶⁹

Replacing the Al layer reduces the interactions between MXene layers during the exfoliation synthesis technique. Therefore, surface termination is crucial in regulating the storage capability of MXenes. By blocking ion transport,

termination by –F and –OH greatly reduces the capacity (from 320 for Ti₃C₂Li₂ to 130 and 67 mA h g⁻¹, respectively).³⁴³ However, by increasing Li mobility and lowering the diffusion barrier, which is lower than that of graphene, termination with chalcogen atoms (S and Se) increases the capacity.³⁴⁴ For non-lithium-ion batteries (NLIBs), MXenes can transport ions of various sizes in addition to Li-ions. Fig. 21 displays the storage capabilities of various ion batteries made of oxygen-terminated and bare MXenes. Due to their lighter weight, bare MXenes work better, and oxygen-terminated MXenes can break down into bare MXene. Additionally, adding a metal layer nearly doubles the ability for different ions.³⁴⁵

The films become more flexible and collect and store more ions on the surface of the pores thanks to the porous structure. A first-cycle capacity of 790 mA h g⁻¹ is provided by a porous Ti₃C₂T_x alloy containing 10 wt% CNTs.³⁴⁷ A potential candidate for Li–S batteries is a 70 wt% Ti₂C–S composite using Ti₂C as the matrix. It has a storage capacity of 1090 mA h g⁻¹ at C/2 and a very low decay rate of 0.05% per cycle.³⁴⁸ Comparably, a combination of layered Ti₃C₂ and 57.6 wt% sulfur has a capacity of 1291 mA h g⁻¹ and can hold onto 970 mA h g⁻¹



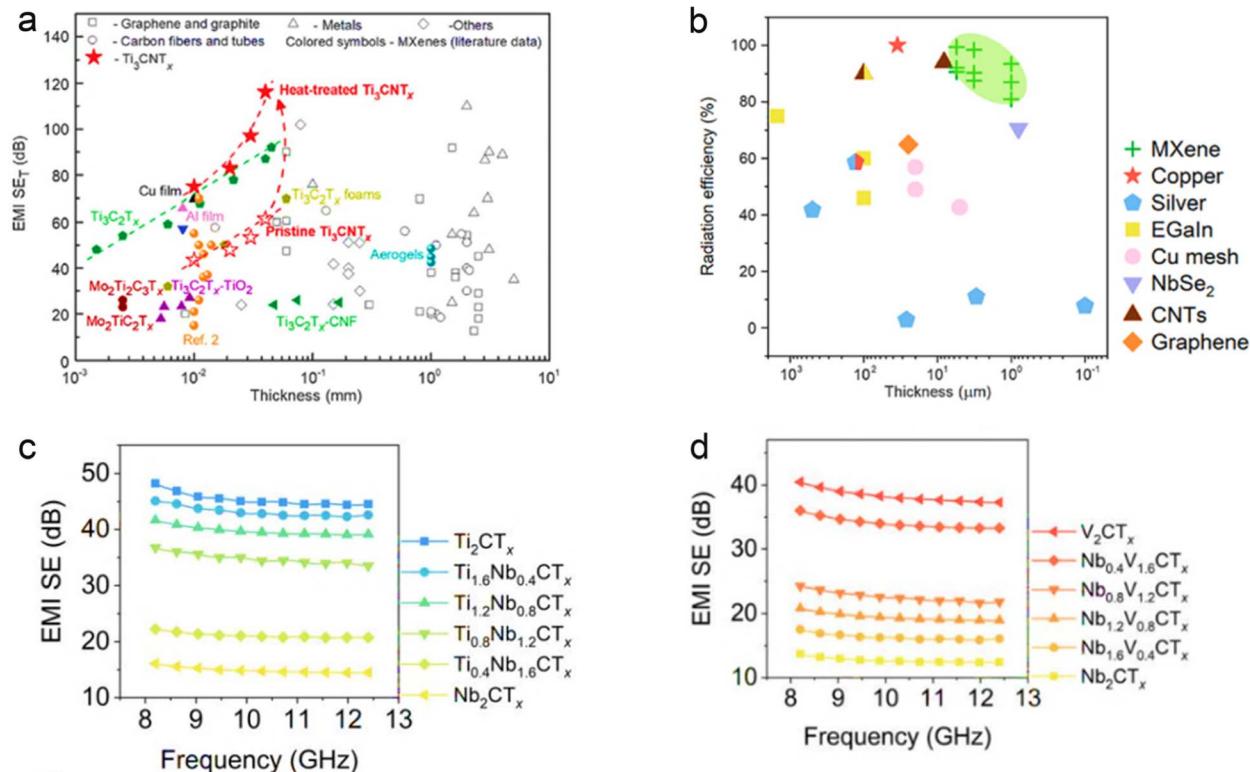


Fig. 19 (a) Comparison of EMI shielding efficiencies of MXenes with carbons and metals. (b) A comparison of radiation efficiency versus thickness for MXene with metals, carbons, and others as patch antennas. (c and d) EMI SE of various MXenes with their solid solutions. Reproduced from ref. 337 with permission from [John Wiley and Sons], copyright [2020].

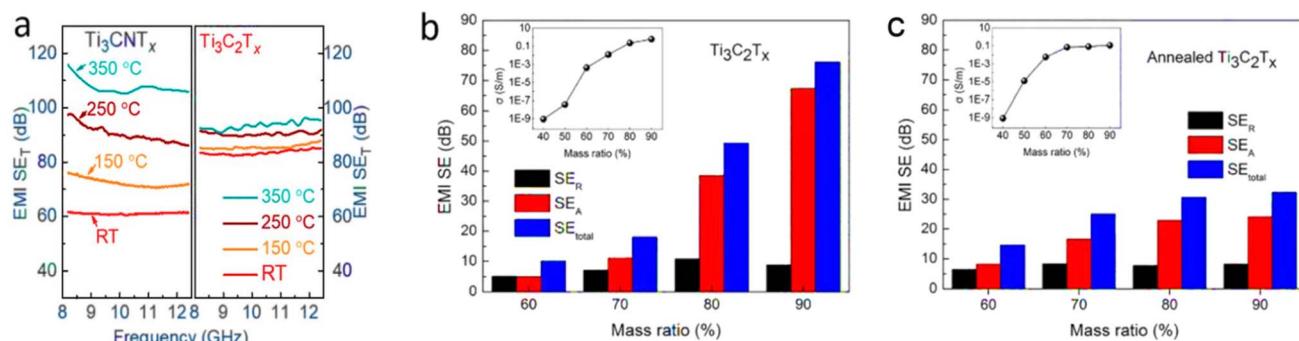


Fig. 20 (a) comparison between Ti_3CNT_x and $\text{Ti}_3\text{C}_2\text{T}_x$ with regard to annealing temperature. (b and c) Annealing effect for $\text{Ti}_3\text{C}_2\text{T}_x$ /wax composites. Reproduced from ref. 340 with permission from American Chemical Society, copyright 2016.

after 100 cycles.³⁴⁹ A simple liquid-phase immersion method is used to create a hybrid of 5 wt% Sn with Ti_3C_2 .^{20,31} MXenes and absorber must therefore be properly paired in order to further improve energy storage.

MXenes are potential candidates for use in energy harvesting and conversion applications due to their mechanical stability and extremely negative triboelectric properties. Adaptable triboelectric nanogenerators (TENGs) can harvest power from human movement.^{350,351} At a matching load impedance of 4.5 M, a frequency of 4.5 Hz, and a force of 8 N, a fabric-based waterproof (FW-TENG) with MXene triboelectric produces 3.69

mW (maximum output peak power) and a power density of 9.24 W m⁻².³⁵¹ $\text{Ti}_3\text{C}_2\text{T}_x$ is one of the finest materials for solar-powered water steam generation because of its extremely high light-to-heat conversion efficiency.³⁵²

High hydrogen evolution reaction (HER) in the materials results in a significant number of oxygen atom openings on the surface. Reducing fluorine concentrations and increasing oxygen concentrations, which serve as catalytic active sites for HER activity, can be used to successfully control MXene surface stoichiometry.³⁵³⁻³⁵⁵ The MXene surface must have greater oxygen and lower fluorine concentrations to be more

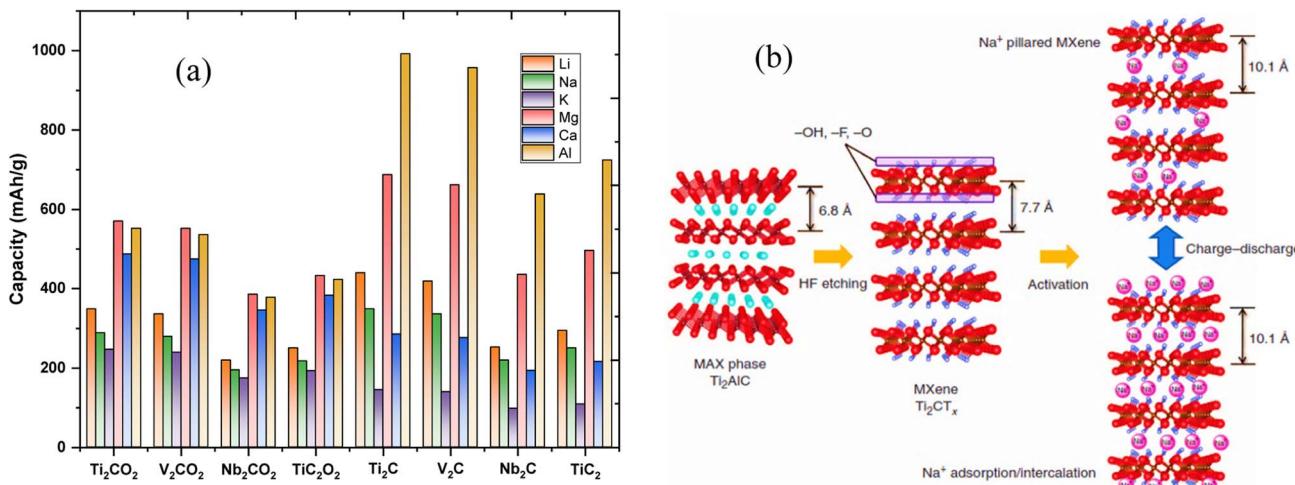


Fig. 21 (a) A study of the storage capacities of various MXene materials. (b) Diagram of the electrochemical activation mechanism in the Ti_2CT_x reaction mechanism, where MXene Ti_2CT_x was created by HF treatment from the precursor Ti_2AlC . The MXene Ti_2CT_x using expansion of Na^+ intercalation and reversible Na^+ (de)intercalation exhibits no alteration in interlayer distance. Reproduced from ref. 346 with permission from Springer Nature, copyright 2015.

catalytically effective toward HER.³⁵⁵ Compared to $\text{Ti}_3\text{C}_2\text{T}_x$ or Ti_2CT_x , which have more fluorine, Mo-based Mo_2CT_x MXenes function better in HER tests.^{353,355} First-principles computations provide the hydrogen interaction with the MXene surface and in the vacancies. It demonstrates that the adsorption energy of hydrogen is sensitive to both surface coverage and vacancy occupancy and that thermoneutral values of hydrogen adsorption may be attained for certain structures with hydrogen in the vacancies. According to calculation, protons can move to vacancies at high cathodic potentials and remain there in a metastable state of hydrogen atoms, but at anodic potential the process is reversed. The first-principles results provide a rationale for the strongly enhanced HER activity that is observed experimentally on $\text{W}_{1.33}\text{C}$ and $\text{Mo}_{4/3}\text{C}$ MXenes.³⁵⁶ By creating gaps on M-sites, $\text{Mo}_2\text{TiC}_2\text{C}_x$ exhibits enhanced catalytic activity for HER.³⁵⁷ The created catalyst exhibits performance overpotentials of 30 and 77 mV for 10 and 100 mA cm^{-2} (Fig. 22) and a mass activity that is about 40 times greater than that of a commercially available platinum-on-carbon catalyst. As a very effective oxygen electrode, a hybrid film (TCCN) comprising $\text{g-C}_3\text{N}_4$ and Ti_3C_2 nanosheets has been developed for overlaying. Through Ti-N interaction, Ti_3C_2 is joined to $\text{g-C}_3\text{N}_4$ to create a porous free-standing film with a hydrophilic surface and conductive framework that performs admirably in Zn-air batteries and OER catalysis.³⁵⁸ When MXene ($\text{Ti}_3\text{C}_2\text{Tx}_2$) nanosheets are bonded to a vertically aligned metal host under ambient circumstances, they are able to produce NH_3 at an extremely low potential with a high faradaic efficiency (5.78%). The increased activity of the basal plane of MXene, which is comparatively inert, is associated with the presence of more exposed edge sites. This work demonstrates that by adjusting active sites and delaying hydrogen evolution activity, NH_3 electrosynthesis selectivity may be significantly increased in the N reduction reaction (NRR).³⁵⁹

Flexible solid-state supercapacitors have attracted a lot of interest for all types of electrochemical energy storage due to the fast development of modern wearable electronics.^{360–365} The fabrication of transparent electronic devices (TEDs) demands a fast charge-discharge rate, high capacitive nature, energy density, and long life under any distorting conditions. High-performance capacitors must have a high current flow and low energy wastage. Due to its high electrical conductivity of 15–100 S cm^{-1} for a 214 nm-thick film, $\text{Ti}_3\text{C}_2\text{T}_x$ is the most extensively researched material.³⁶⁶ Rolled sheets of $\text{Ti}_3\text{C}_2\text{T}_x$ exhibit volumetric capacitances of up to 900 F cm^{-3} in 1 M H_2SO_4 electrolyte, and the capacitance remains constant even after 10 000 cycles (Fig. 23).²⁸⁸ However, $\text{Ti}_3\text{C}_2\text{T}_x$ paper, which is more pliable, offers 350 F cm^{-3} .³⁶⁷ Comparably, 1315 F cm^{-3} is revealed by V_2CT_x particles in H_2SO_4 electrolyte, and they maintain 77% of their capacitance even after one million cycles at 100 A g^{-1} .²⁶⁶ A hybrid electrode made of polyaniline and graphene encapsulated Ti_2CT_x exhibits an exceptional level of cycling stability and a volumetric capacitance of 1143 F cm^{-3} in 1 M H_2SO_4 .³⁶⁸ Additionally, an Nb_2CT_x /CNT paper electrode, which has a polypropylene membrane, offers 325 F cm^{-3} capacitance at 5 mV s^{-1} , but the performance degrades with rising scanning rate.³⁶⁹ Similar results are obtained with a $\text{Ti}_3\text{C}_2\text{T}_x$ -CNT alloy, which exhibits 245 F cm^{-3} capacitance at 2 mV s^{-1} .³⁷⁰ Due to the substantial interlayer spaces between the MXene sheets, a hybrid with a pyrrole to $\text{Ti}_3\text{C}_2\text{T}_x$ ratio of 1:2 exhibits a volumetric capacitance of 1000 F cm^{-3} at 5 mV s^{-1} with 92% retention even after 25 000 cycles.³⁷¹ The electrochemical process can be managed and optimized using solid solutions of MXenes. With a rise in Nb content, $\text{Ti}_{2-y}\text{Nb}_y\text{CT}_x$ and $\text{C}_{2-y}\text{Nb}_y\text{CT}_x$ both exhibit a decrease in redox peak intensity and an improvement in cycling stability.³⁷²

By using current collectors other than glassy carbon, such as graphite, an MXene electrode is able to push capacitance very close to its theoretical limit. Additionally, MXene macroporous



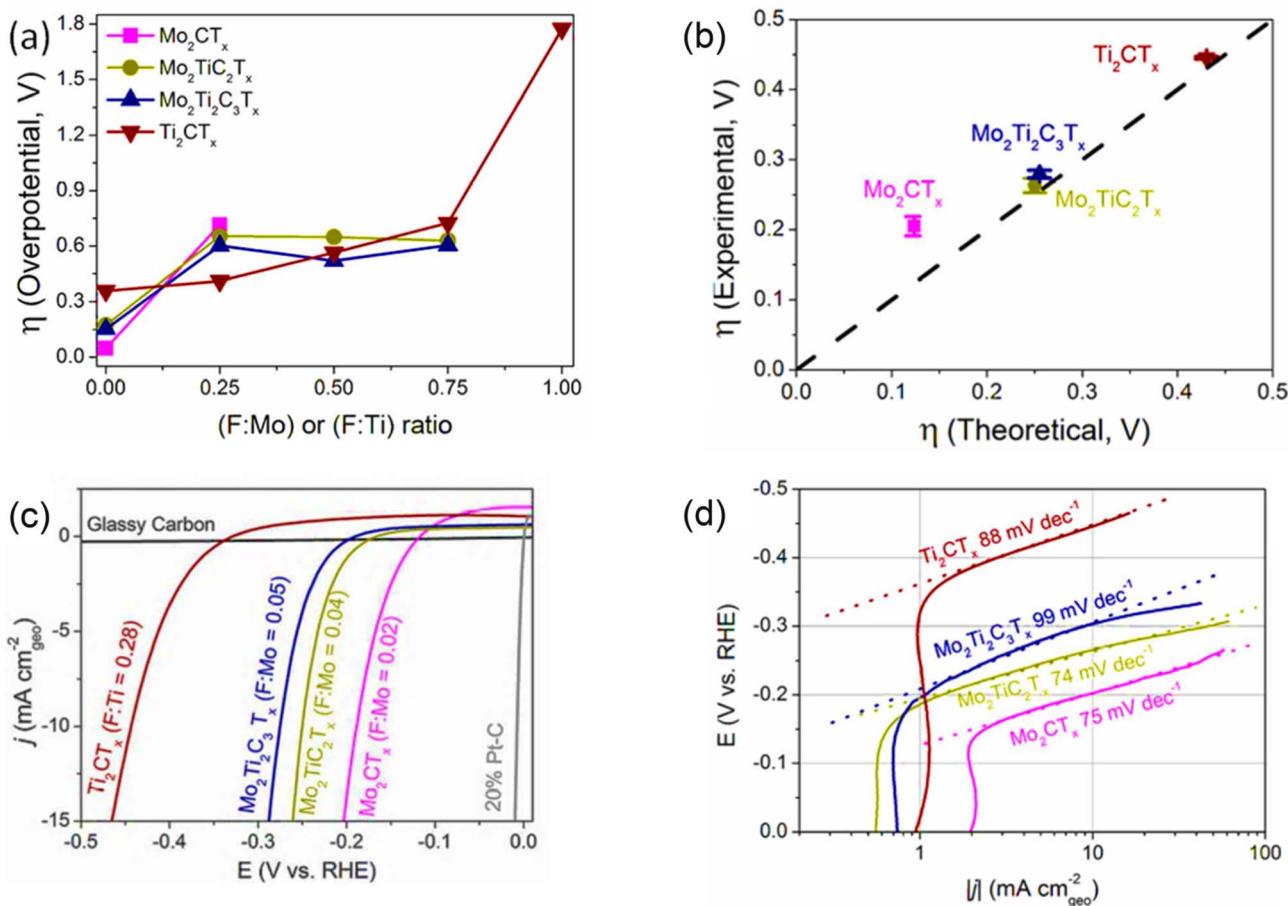


Fig. 22 (a) DFT-calculated HER overpotential based on F basal plane coverage (F : Mo or F : Ti ratio). (b) Analysis of experimental and theoretical overpotentials. Ideal conditions that are consistent with theoretical numbers are shown by dashed lines. (c) Linear sweep voltammetry (LSV) used to measure HER activity, and (d) a Tafel diagram of MXenes in 0.5 M H_2SO_4 . Reproduced from ref. 355 with permission from American Chemical Society, copyright 2018.

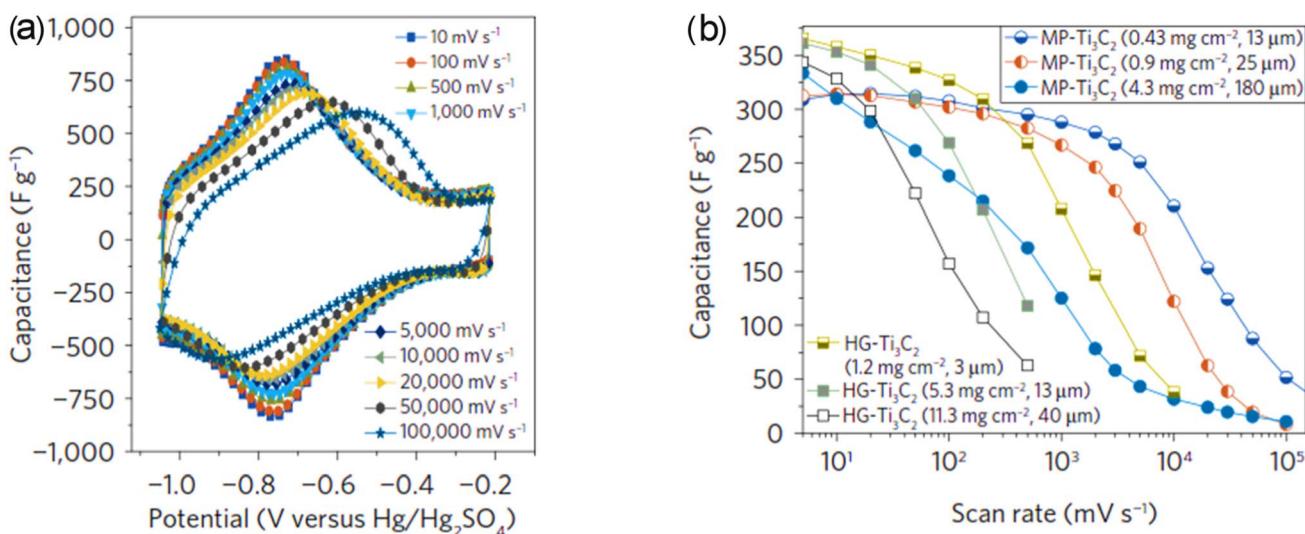


Fig. 23 (a) Measurement of CV for a 90 nm thick $\text{Ti}_3\text{C}_2\text{T}_x$ MXene at scan speeds ranging from 10 to 100 000 mV s^{-1} . (b) The gravimetric rate performance of MXene film preparation procedures and mass loading dependence. Reproduced from ref. 373 with permission from Springer Nature, copyright 2017.

electrode designs allow for exceptional capacitance withholding even at charge-discharge rates above 1 V s^{-1} : 210 F g^{-1} at 10 V s^{-1} and 100 F g^{-1} at 40 V s^{-1} , which are exceptional compared to the finest carbon supercapacitors known to man. Hydrogel electrodes outperformed state-of-the-art supercapacitor materials in terms of the volumetric performance of RuO_2 , demonstrating remarkable volumetric capacitance up to 1500 F cm^{-3} and areal capacitance up to 4 F cm^{-2} .³⁷³

A quick charge-discharge rate, high capacitive nature, energy density, and a long life in any distorting situation are requirements for the fabrication of transparent electronic devices (TCDs). More than 90% transmittance and less than 100 sq^{-1} sheet resistance (R_s) of the electrode are required to accomplish these properties. Indium tin oxide has previously possessed these characteristics, but the development of this new industry is hampered by the inherent fragility of the material and its expensive fabrication costs.^{374,375} 2D materials are presently thought to be emerging as a possible candidate to resolve every problem facing developing TCD industries. Flakes of $\text{Ti}_3\text{C}_2\text{T}_x$ that are aligned in parallel exhibit remarkable success in producing low resistivity and high transmittance. MXene, which has a transmittance of over 90%, can provide R_s of 1032 sq^{-1} , while graphene exhibits a value that is three times higher, as shown in Fig. 24.³⁷⁶⁻³⁷⁹ In another study, $\text{Ti}_3\text{C}_2\text{T}_x$ film covering polyethylene terephthalate measured at 424 sq^{-1} R_s had 57% transmittance.³⁸⁰ Similarly, $\text{Ti}_3\text{C}_2\text{T}_x$ alloy with silver nanowire that has undergone solution processing exhibits R_s of $13-15 \text{ sq}^{-1}$ and 84-89% transmittance.^{381,382}

Additionally, DC conductivity and bulk capacitance in relation to optical conductivity can be used to evaluate the competitiveness of a material for a TCD.³⁷⁹ MXene also has a higher DC to optical transmission ratio than other graphene materials, as shown in Fig. 24(b). MXene thin films also have the highest capacitance of any thin film.³⁷⁹ In comparison to other MXene composites, $\text{Ti}_3\text{C}_2\text{T}_x$ and polycation layer-by-layer assembly provides 24 times more conductivity and 3 times better capacitance.³⁸³

4.4.8 Challenges and outlook. The production of carbide MXenes has advanced significantly, whereas that of nitrides is lagging behind. Al is etched, but other A elements are less frequently etched in the MAX precursor stages, so it is important to determine the best and safest etchant. Additionally, a risky HF etchant should be avoided, and LiF and HCl-based *in situ* HF production should be increased. For increased use of MXenes in upcoming chemical and manufacturing technologies, large-scale (preferably $>30 \text{ m}$) synthesis methods and environmentally friendly, green techniques must be developed. To integrate MXenes on chips using conventional and widely available micro-fabrication device technology, a vapour-phase technique must be developed. To further the comprehension of the properties of MXenes, it is necessary to combine the efforts of theoretical and experimental research. To forecast new precursors, topological insulators, and ferromagnetic MXenes, there must be fewer defects and proper control over structure and surface termination. Therefore, it is necessary to create minimally intrusive etching and delamination techniques for the available non-MAX and MAX phase precursors. Our collective knowledge of the basic characteristics of well-known 2D materials like graphene, TMDs, *etc.* can be used to investigate the most intriguing characteristics of MXenes.

Li-atom mobility computations show that M_2C and M_3C_2 monolayered surfaces with notably low diffusion barriers—reportedly 0.01 eV for Ti_2C , V_2C , Sc_2C , and Zr_2C —have very high Li-atom mobility. It follows that multilayered transition-metal carbides might be employed as fast-charging electrode materials. More precisely, thorough experimental and theoretical studies are needed to examine the energy storage potential of Sc, Ti, V, and Zr based MXene materials. On the basis of this study, additional research on the electronic and optical characteristics of MXenes is also recommended, which could help to bridge the knowledge divide between theoretical predictions and experimental observations.

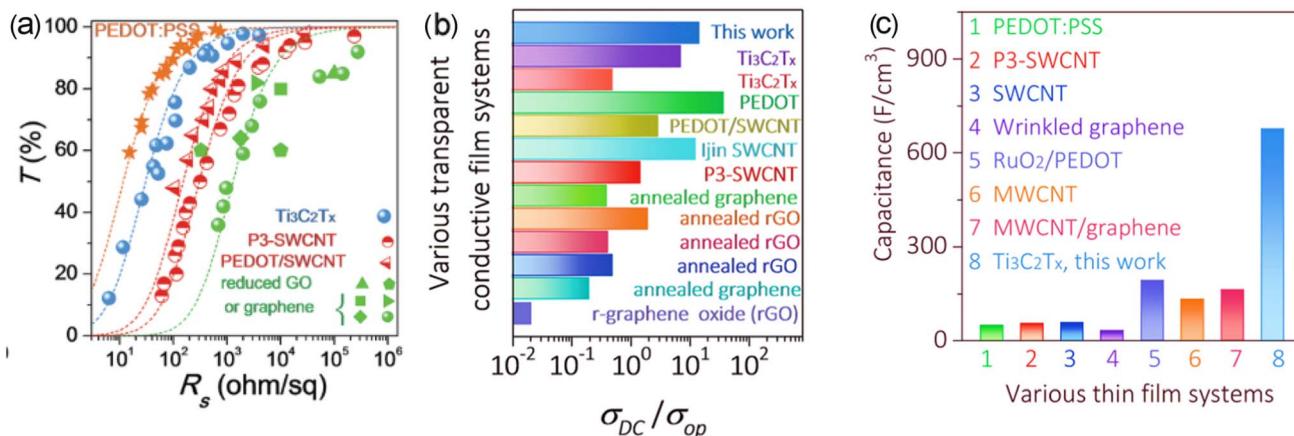


Fig. 24 Optoelectronic properties of $\text{Ti}_3\text{C}_2\text{T}_x$ films: (a) the transmittance (T) at 550 nm as a function of sheet resistance R_s and (b) comparison of $\text{Ti}_3\text{C}_2\text{T}_x$ with other transparent thin films. (c) Comparison of σ_{DC}/σ_{op} in $\text{Ti}_3\text{C}_2\text{T}_x$ films to various other transparent capacitive electrodes (TCEs). Reproduced from ref. 379 with permission from John Wiley and Sons, copyright 2017.



5. Concluding remarks

The current century is acknowledged by scientists to be the one of nanotechnology. One of the key elements in the advancement of nanotechnology is the creation of two-dimensional nanostructured materials (2D NSMs). Nanosheets of 2D NSMs and layered structured materials are widely studied because of their distinctive physicochemical characteristics. For 2D NSMs, efficient and approachable synthesis methods are more crucial. This review includes synthesis methods as well as the most recent advances in 2D NSM applications outside of graphene. Graphene is the perfect structure to comprehend the fundamental physicochemical characteristics of 2D NSMs and their applications. Different 2D NSMs other than graphene have recently become a very academically rigorous study area in 2D nanomaterials. 2D NSMs exhibit extremely intriguing electronic characteristics that are strikingly similar to or dissimilar from those of graphene. Due to the fact that their surface to volume ratios are different from those of their bulk counterpart, 2D NSMs actually exhibit distinctive physical and chemical properties. What is more exciting is that these properties can be excitingly tailored using strain, doping, and electric fields for many technological applications. These 2D layered materials are used in MEMS and NEMS electronic devices, energy storage devices, biosensors, supercapacitors, solar cells, and catalysts due to their versatile and excellent optical and electronic characteristics.

There are difficulties in developing practical experimental methods for the massive manufacturing of monolayered and multilayered 2D NSMs. The most significant 2D materials beyond graphene are those with few layers and big surface areas. The optical, mechanical, chemical, and thermal properties of TMD and h-BN nanosheets, germanene, and silicene have not yet been fully revealed, despite intensive study of their electronic properties. Techniques for making MXenes have recently been developed, and a variety of their characteristics are currently the subject of extensive research. This review summarizes synthesis methods and discusses the difficulties and potential of MXenes; ideally, this will hasten the investigation of 2D NSMs other than graphene.

Even when silicon with a thin dielectric film is used, the transistor performance of TMD MX_2 materials like MoS_2 and WS_2 is significantly enhanced. For the electronic sectors, the TMD semiconducting single layer has opened a door to groundbreaking and fascinating research. MoS_2 has been the subject of intensive research, but little is known about the optical and electronic properties of metal chalcogenide nanosheets. Based on theoretical research, silicene and germanene exhibit almost identical graphene-like characteristics, but there is a severe lack of experimental data for these two materials. Additionally, the majority of research on germanene and silicene is conducted on metallic substrates, which are inappropriate for use in electronic devices. The fabrication of two materials on a non-metallic or insulating substrate presents a greater challenge. Beyond graphene, MXenes have been extensively explored using theoretical and experimental methods in 2D NSM. This review thoroughly explains the prospects and obstacles for MXenes,

paving the way for the discovery of previously undiscovered properties. For the integration of MXenes on chips using conventional and widely available microfabrication device technology, a vapor-phase technique must be developed. To better comprehend the characteristics of MXenes, theoretical and experimental research must work together.

It is true that there is still much to learn about 2D compounds other than graphene. To address the challenges of nanotechnology, the peculiar properties of 2D NSMs can be unlocked and intriguing new breakthroughs made. New 2D NSMs with intriguing properties have been created after a lot of work and will be useful to the electronic sectors.

Conflicts of interest

The authors affirm that they have no known financial or interpersonal conflicts that might have looked to have an impact on the research presented in this paper.

Abbreviation

| | |
|-------|-------------------------------------------|
| h-BN | Hexagonal boron nitride |
| BP | Black phosphorus |
| TMD | Transition metal dichalcogenides |
| MOFs | Metal-organic frameworks (MOFs) |
| LDHs | Layered double hydroxides |
| COFs | Covalent organic frameworks |
| Xenes | Monoelemental compounds metal oxides |
| TMHs | Transition metal halides |
| XRD | X-ray diffraction |
| SEM | Scanning electron microscope |
| TEM | Transmission electron microscope |
| STM | Scanning tunnelling microscopy |
| EELS | Electron energy loss spectra |
| AFM | Atomic force microscopy |
| PL | Photoluminescence |
| EDX | Energy dispersive X-ray analysis |
| DLS | Dynamic light scattering |
| GO | Graphene oxide |
| DFT | Density functional theory |
| UV | Ultraviolet |
| QLED | Quantum dot light-emitting diodes |
| HIL | Hole injection layer |
| LED | Light-emitting diodes |
| PV | Photovoltaics |
| GQDs | Graphene quantum dots |
| ConA | Concanavalin A |
| FRET | Fluorescence resonance energy transfer |
| ssDNA | Single-stranded deoxyribonucleic acid |
| PEG | Polyethylene glycol |
| SOC | Spin-orbit coupling |
| MBE | Molecular beam epitaxy |
| ARPES | Angle resolved photoemission spectroscopy |
| QSHE | Quantum spin Hall effect |
| FET | Field effect transistor |
| NM | Nonmagnetic |
| FM | Ferromagnetic |



| | |
|-------|---------------------------------------|
| GGA | Generalized gradient approximation |
| EELS | Electron energy loss spectra |
| NMP | N-methylpyrrolidone |
| DMF | Dimethylformamide |
| DOX | Doxorubicin hydrochloride |
| BNNS | Boron nitride nanosheets |
| PMMA | Polymethyl methacrylate |
| BNONS | BN oxide nanosheets |
| DCE | 1,2-Dichloroethane |
| TFT | Thin film transistor |
| EDLC | Electrical double layer capacitance |
| SIBs | Sodium-ion batteries |
| LIBs | Lithium-ion batteries |
| DOS | Density of states |
| TIs | Topological insulator |
| TENGs | Flexible triboelectric nanogenerators |
| HER | Hydrogen evolution reaction |
| NRR | N reduction reactions |
| OER | Oxygen evolution reaction |

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